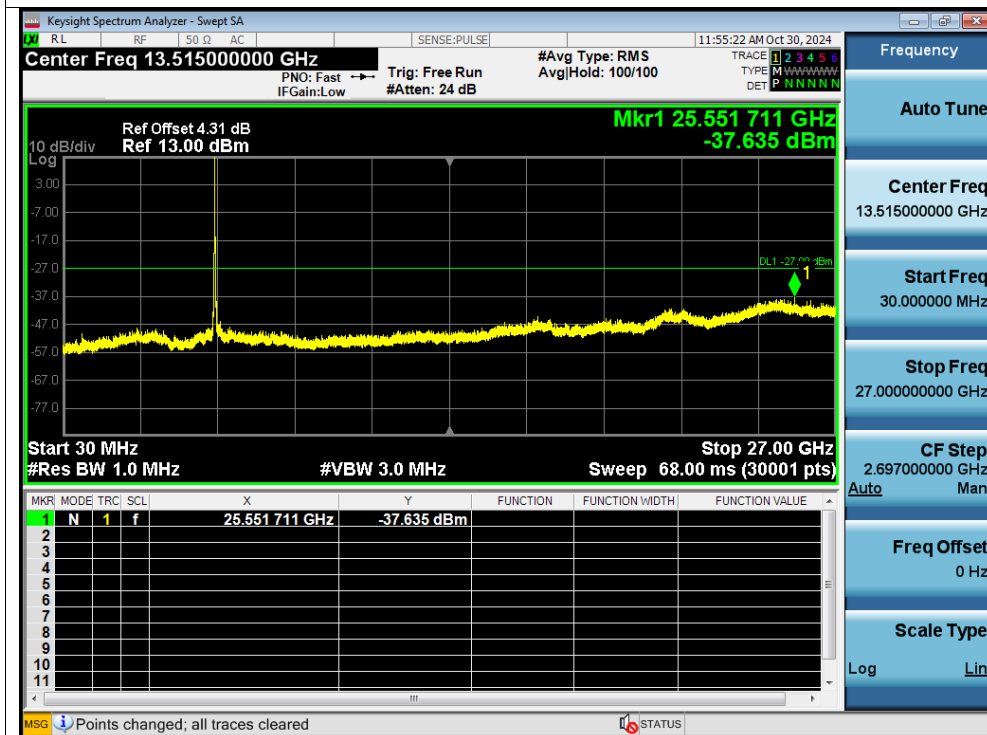
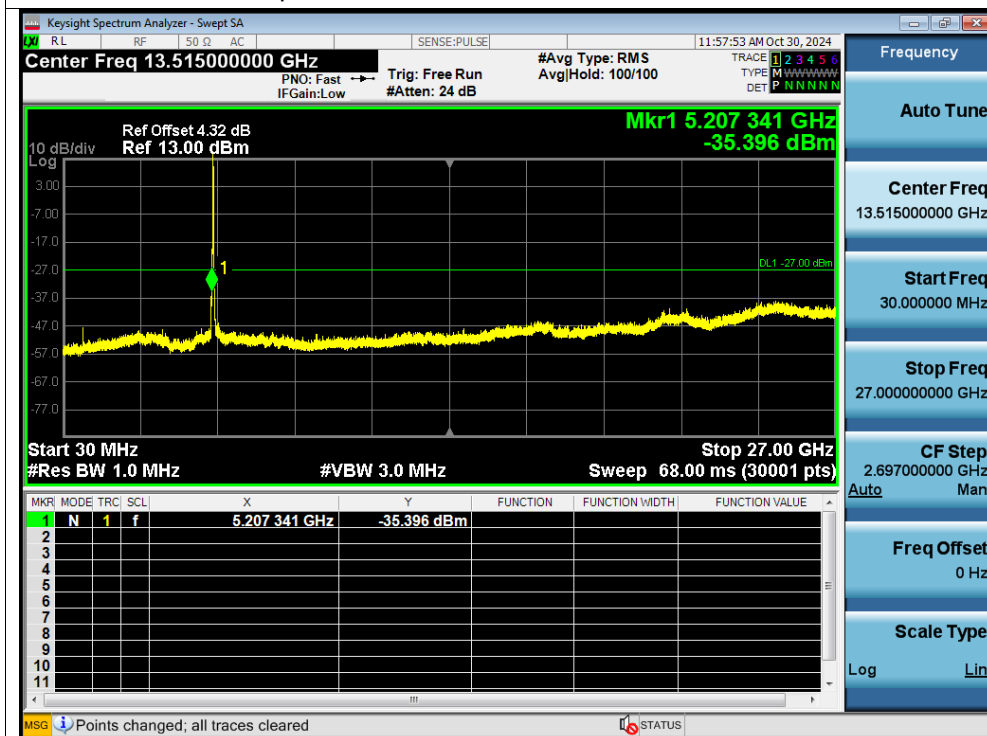
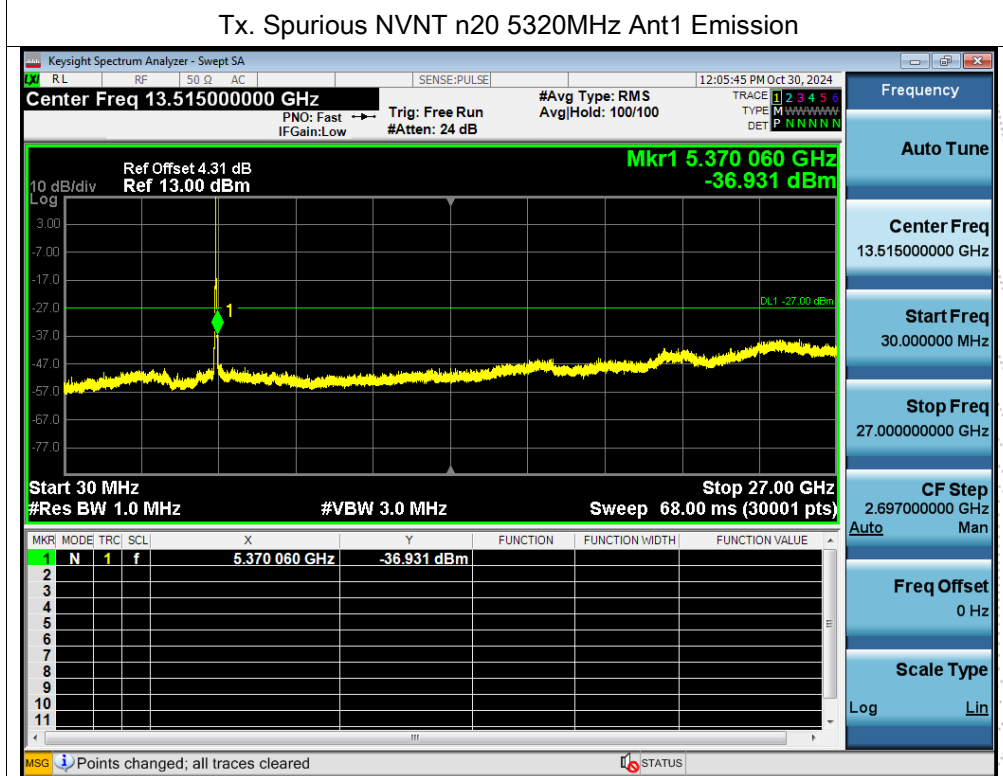
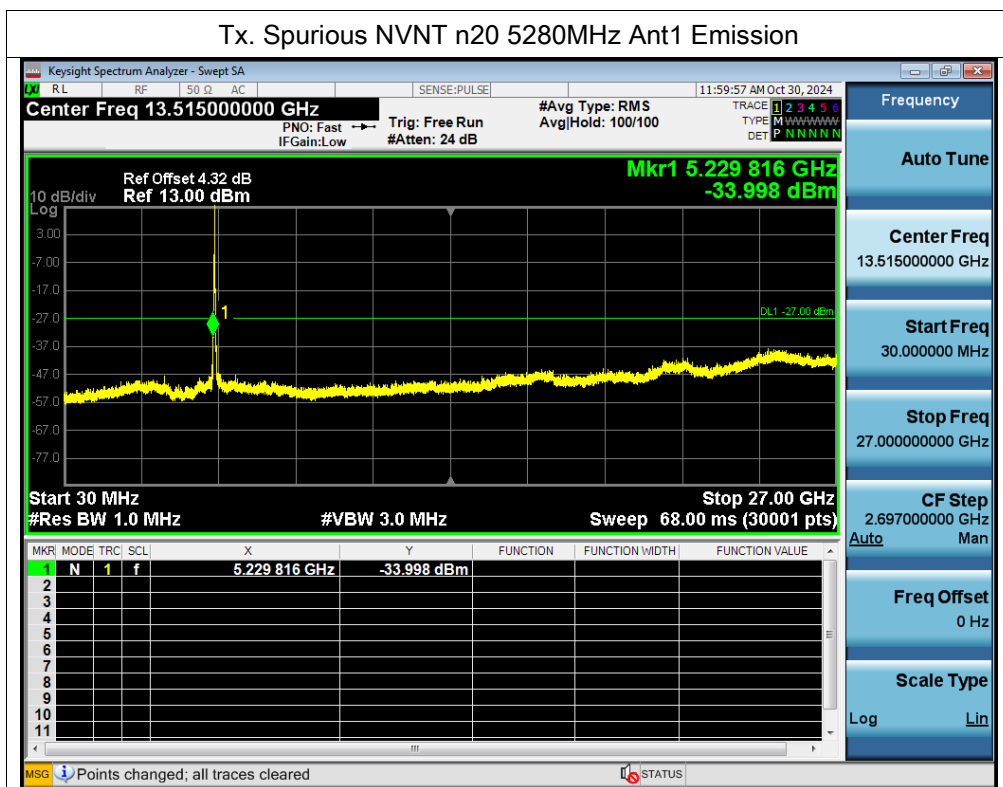


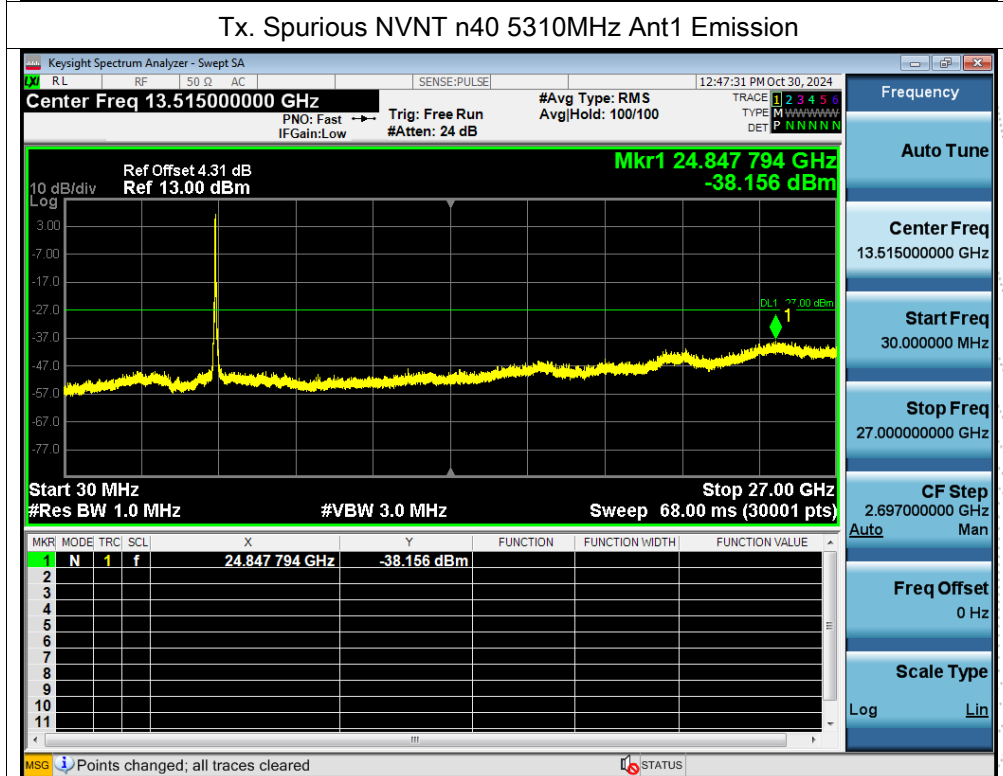
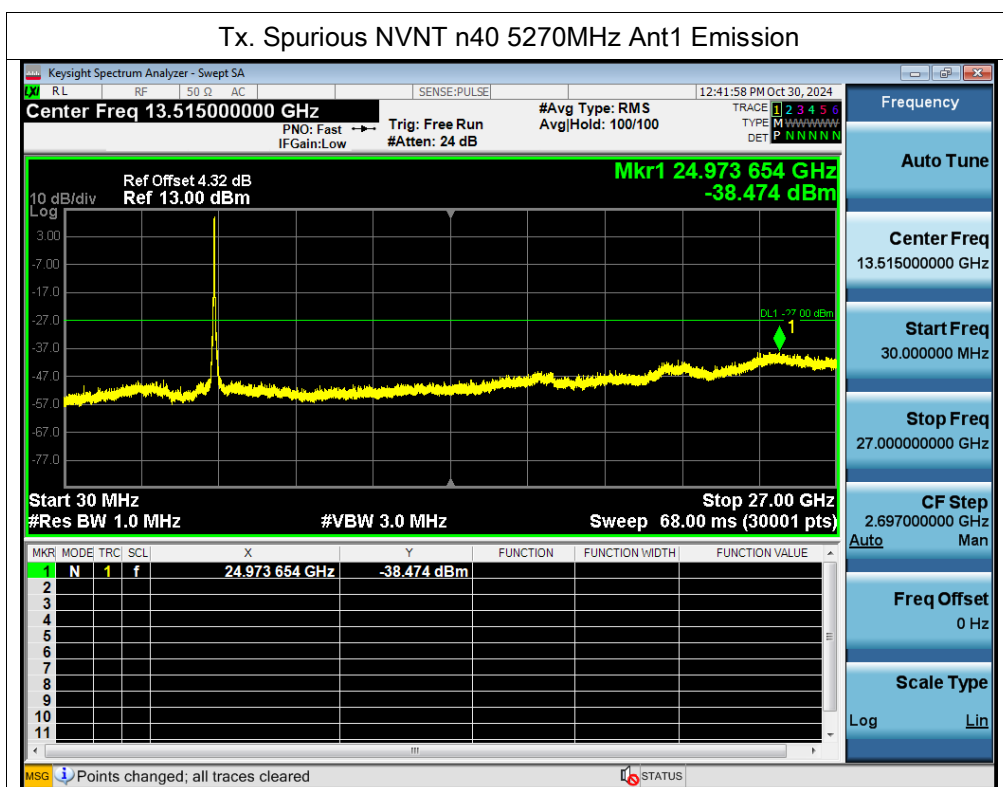
Tx. Spurious NVNT a 5320MHz Ant1 Emission

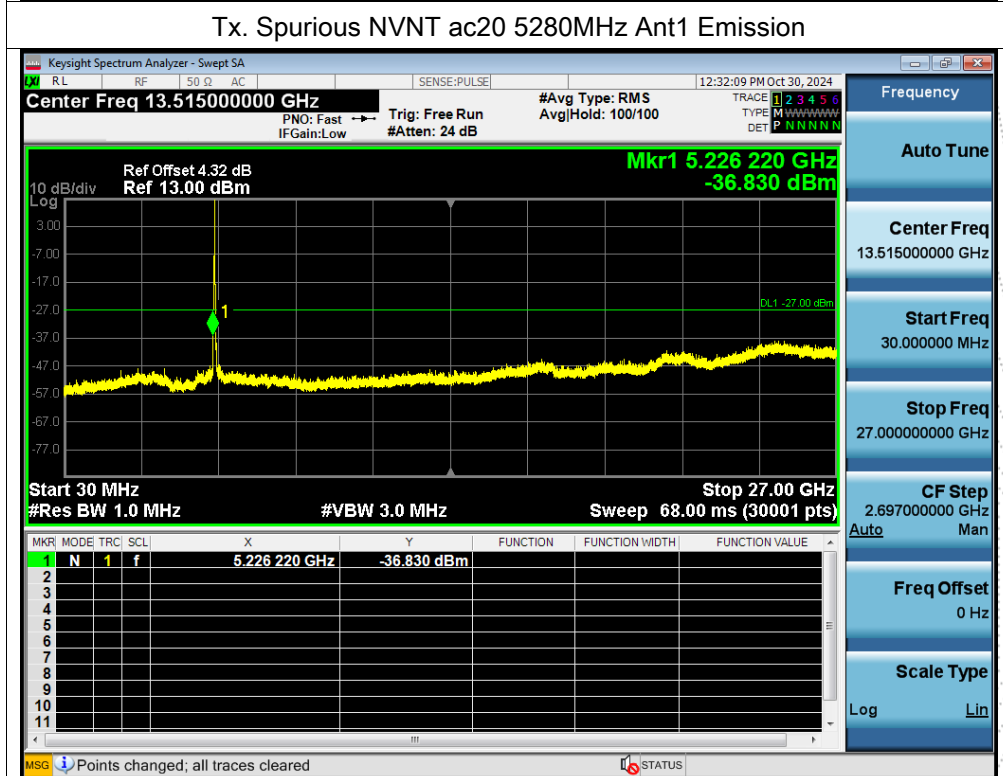
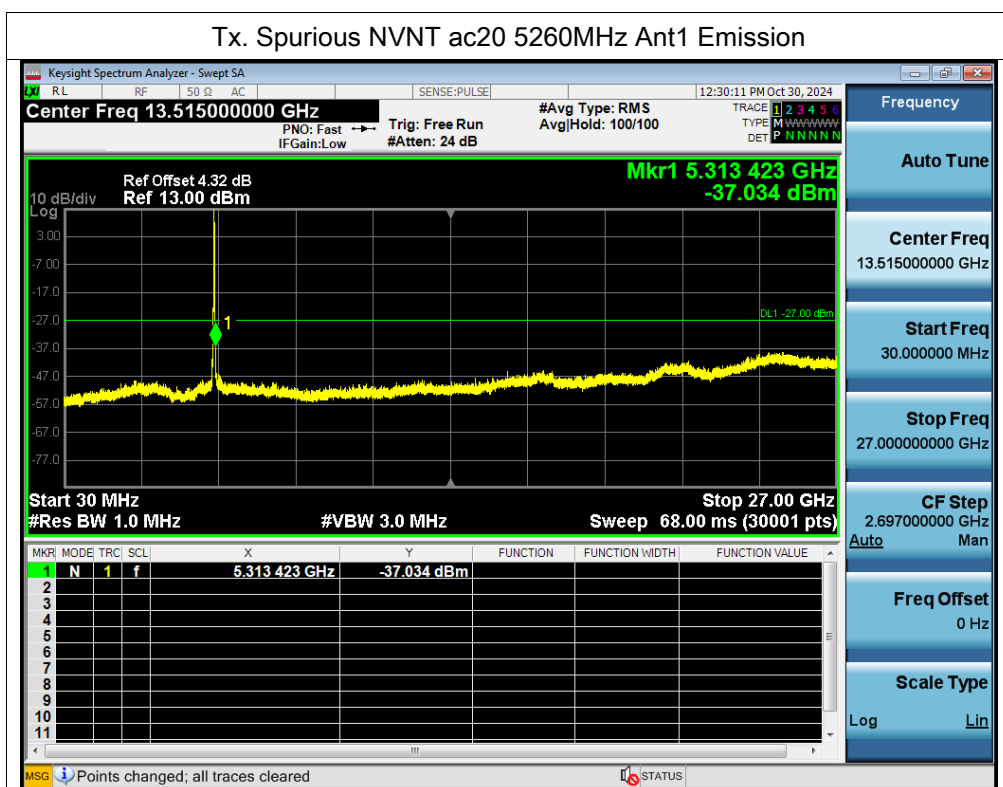


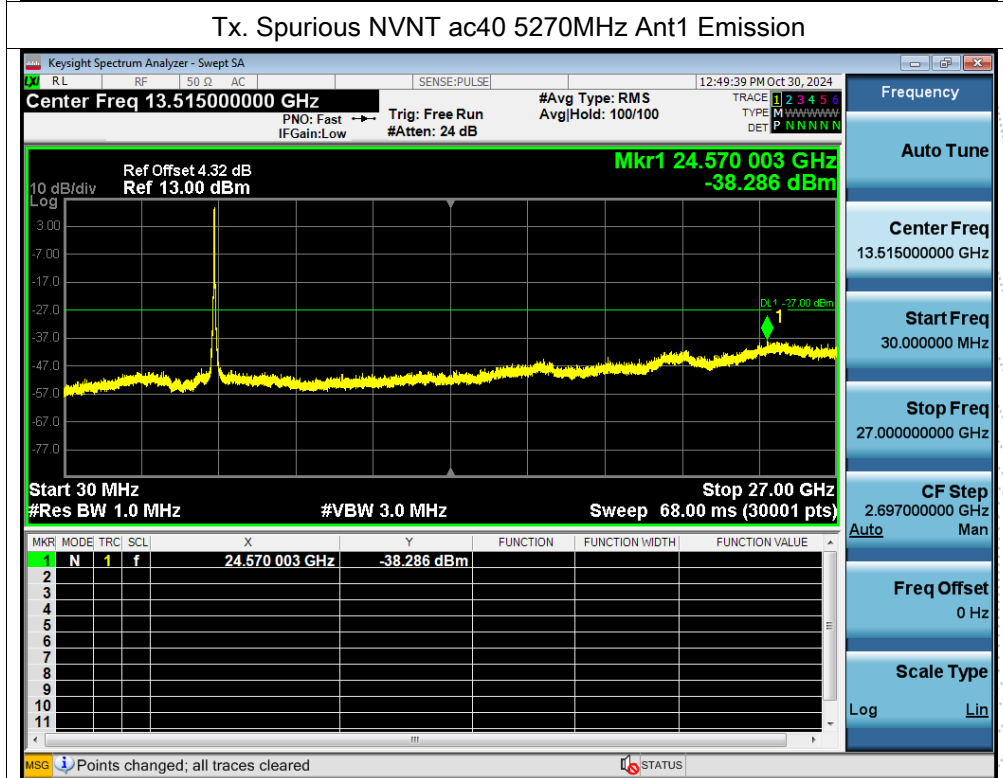
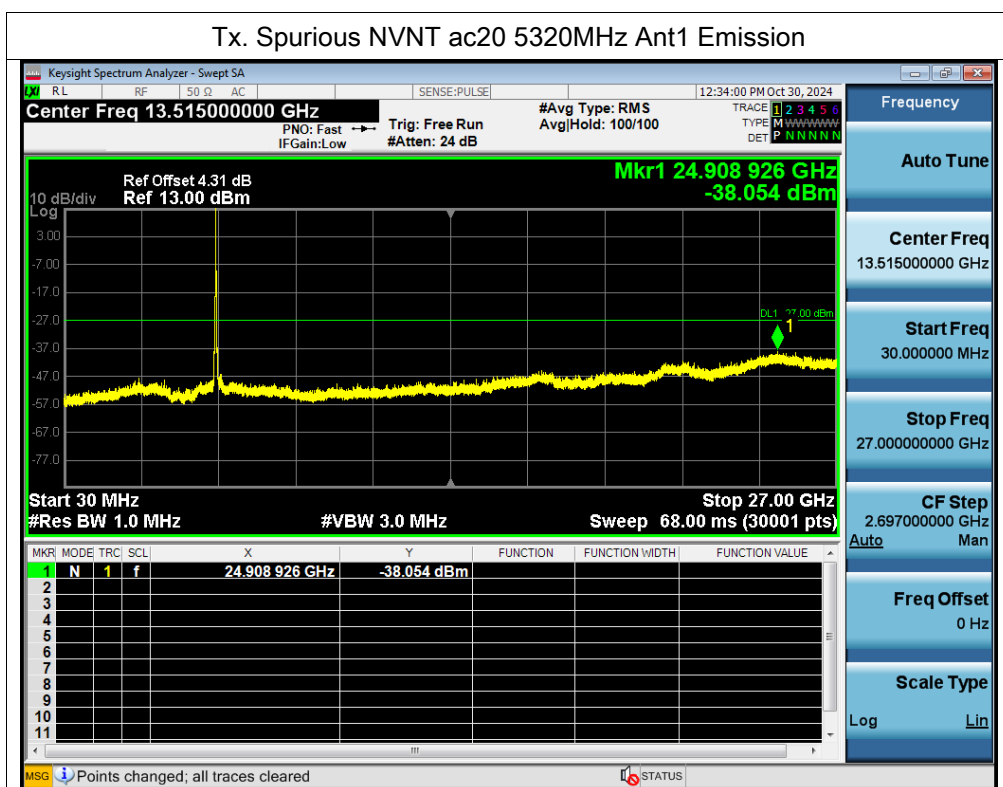
Tx. Spurious NVNT n20 5260MHz Ant1 Emission

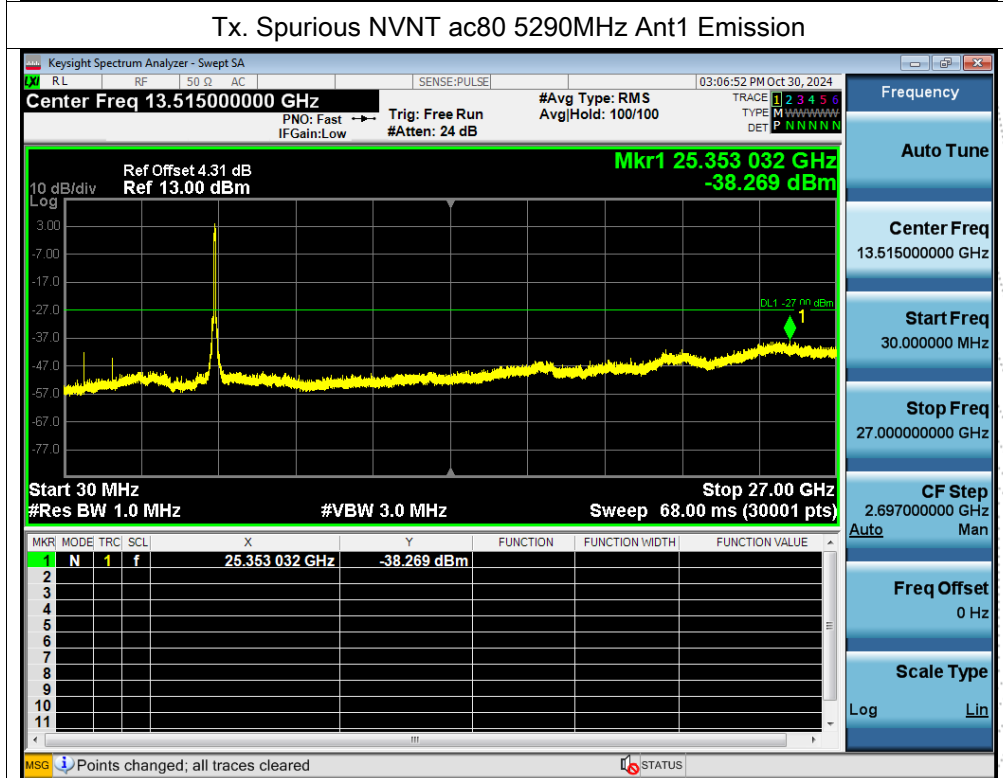
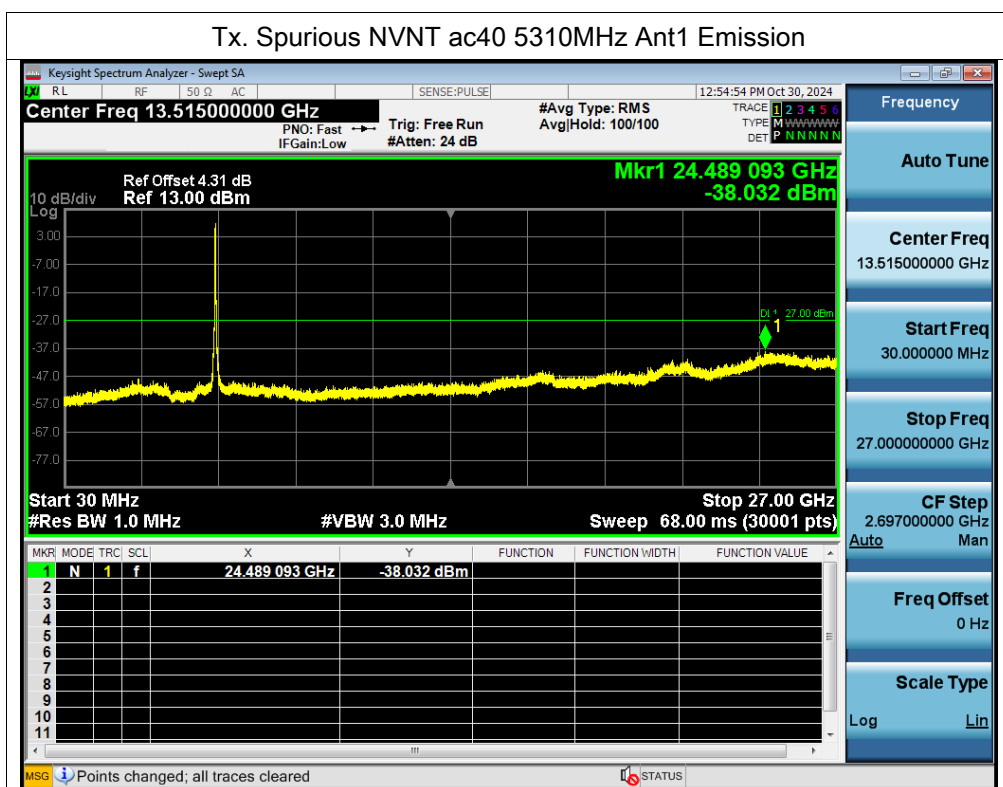




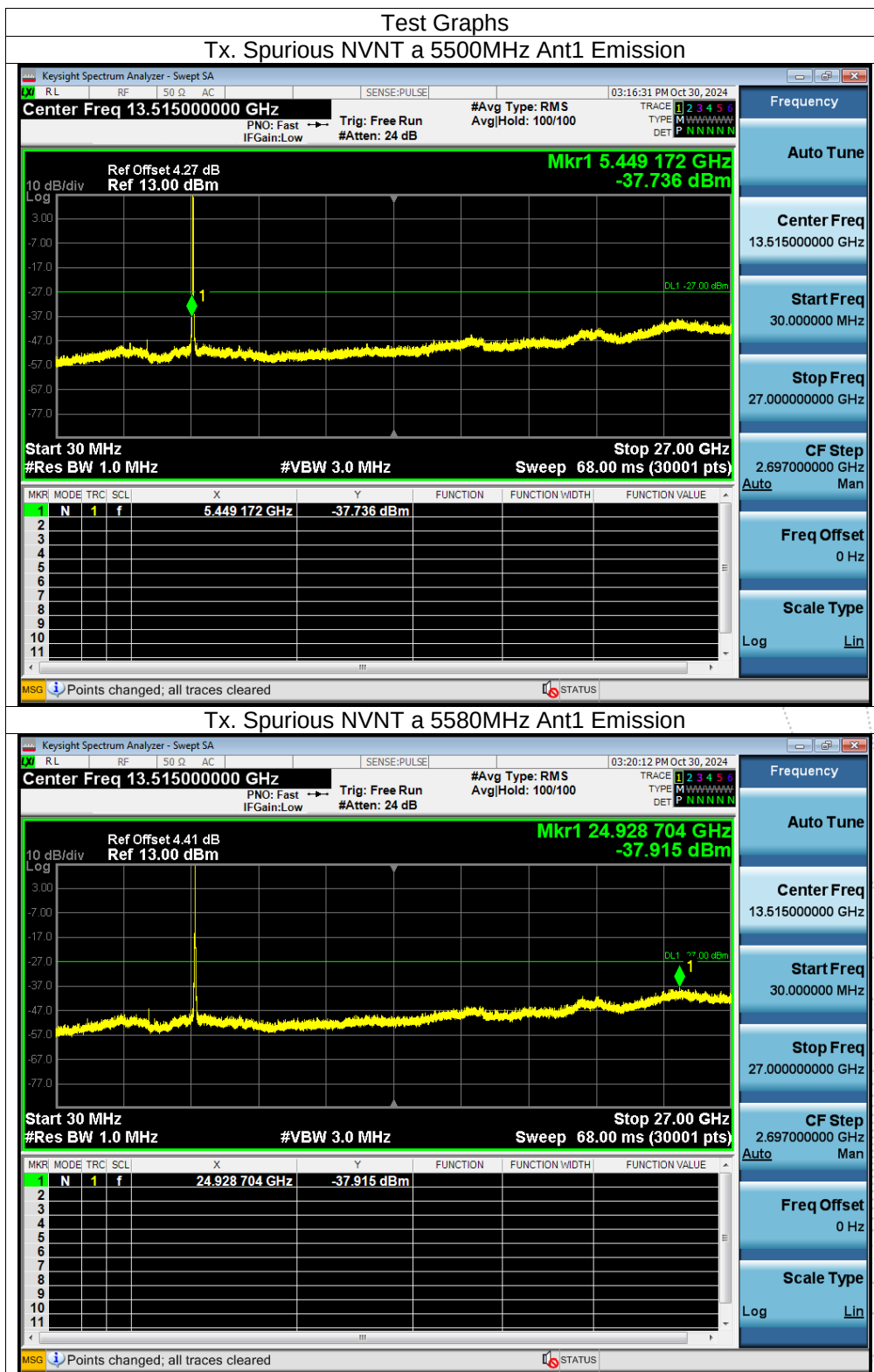


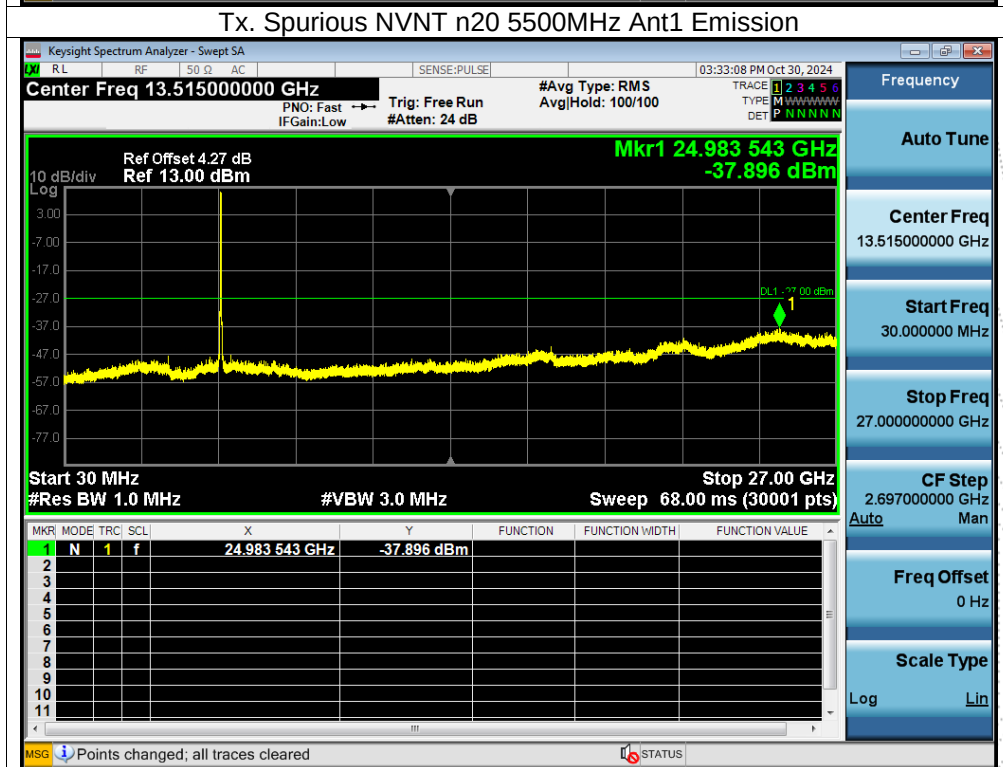
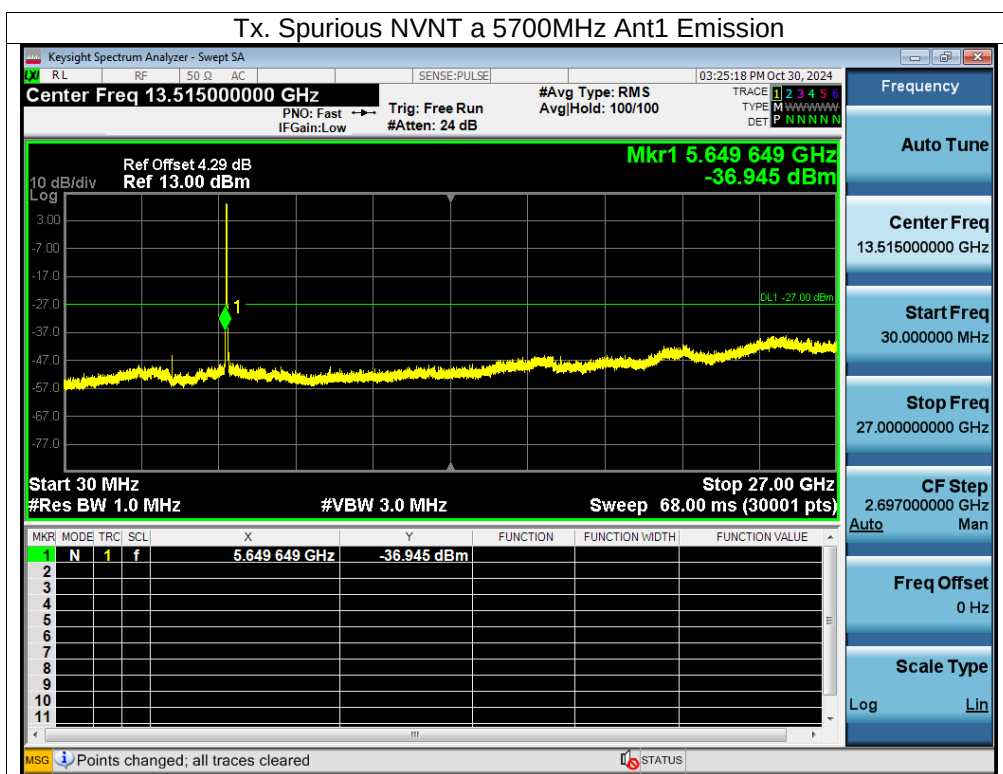


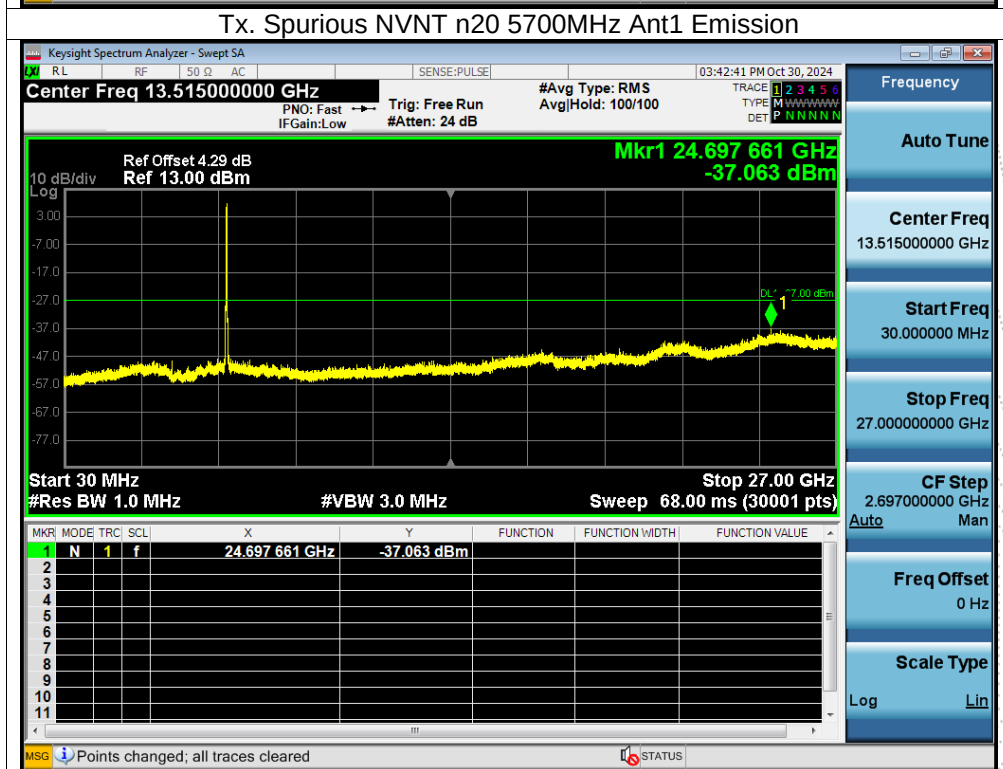
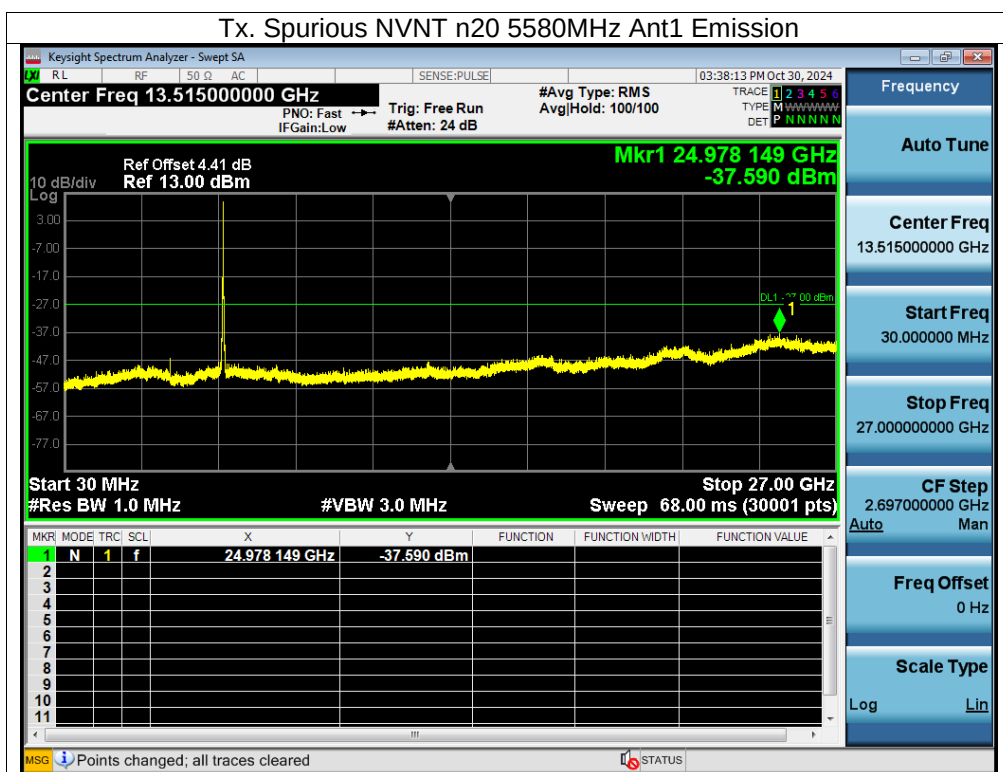


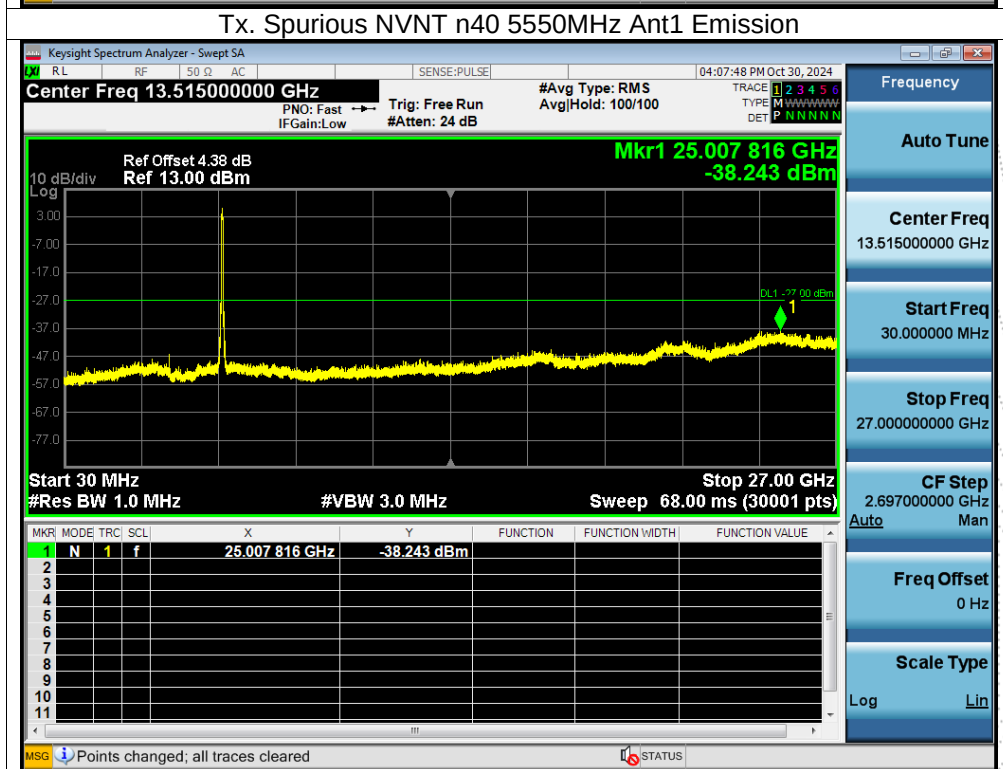
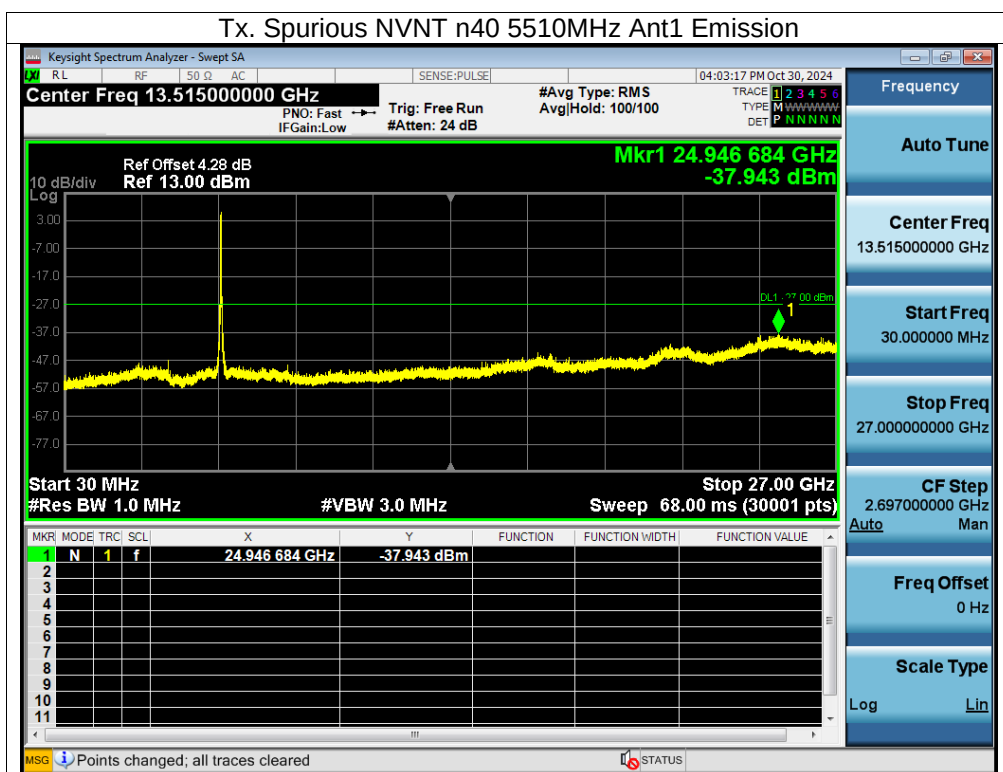


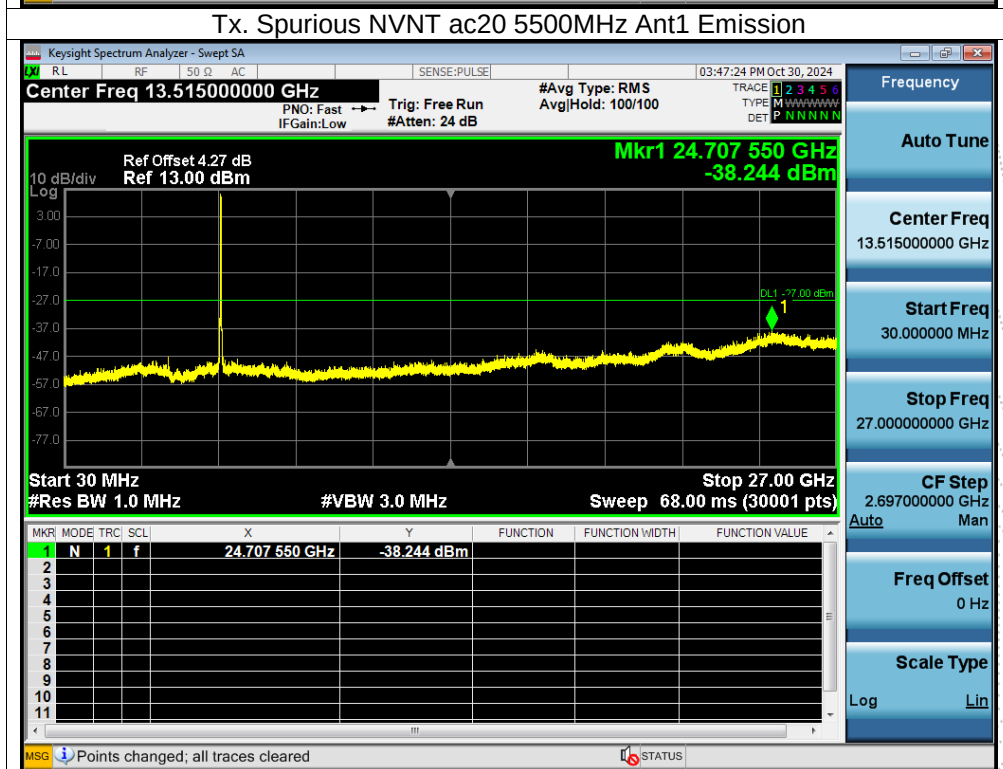
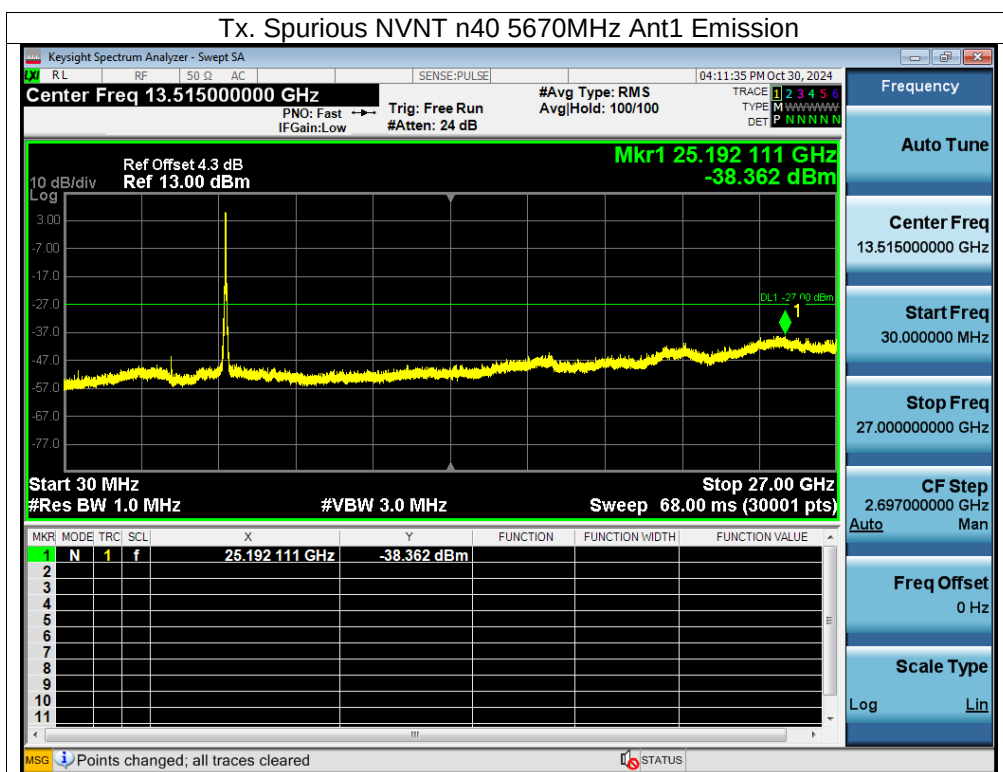
Test Mode:	5500-5700MHz
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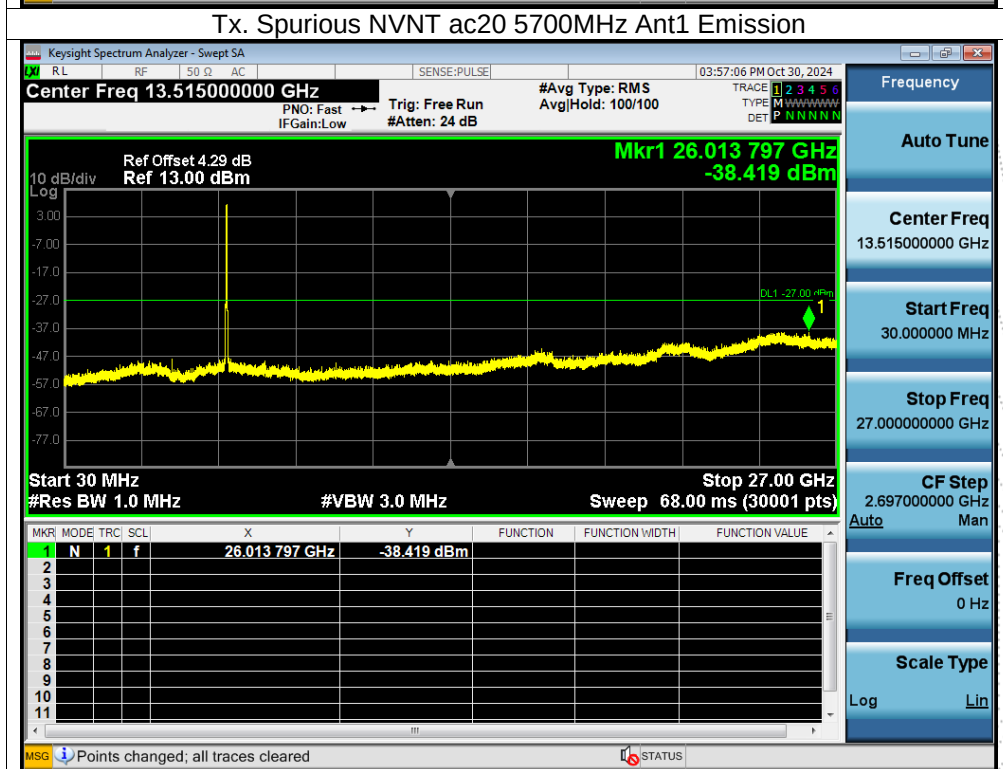
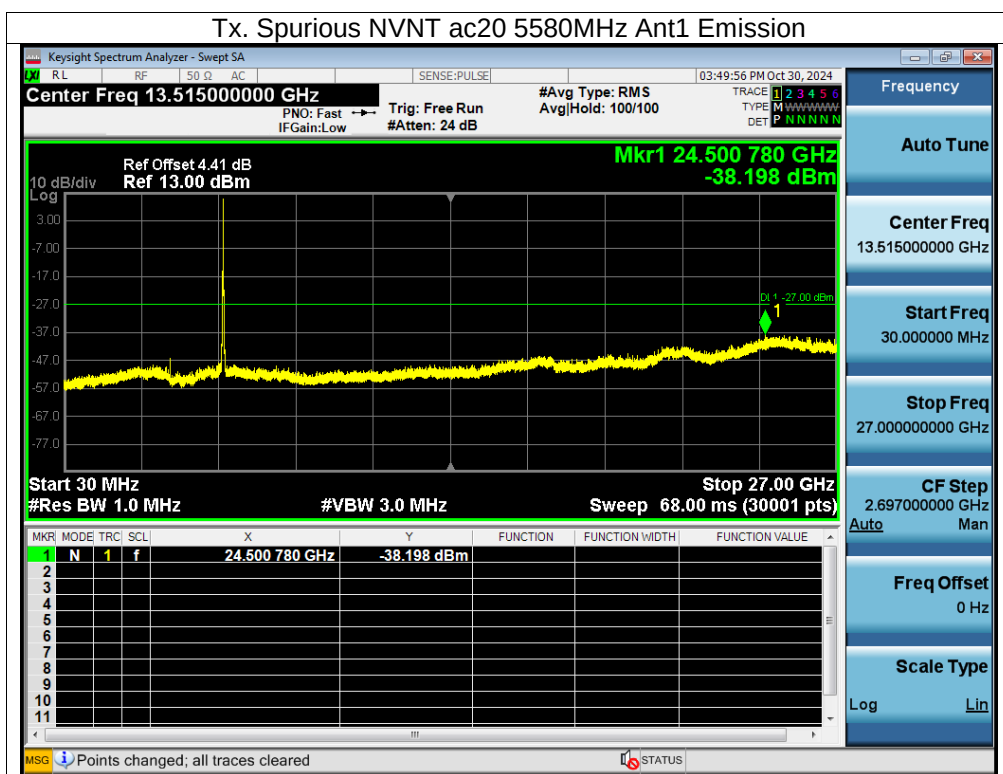


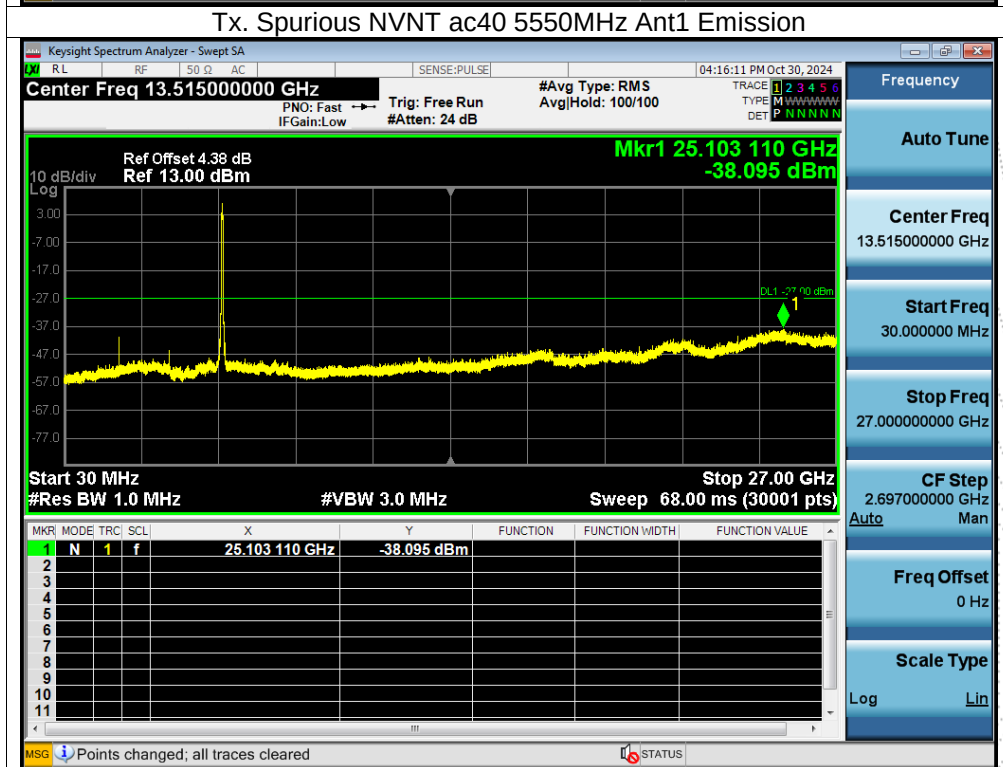
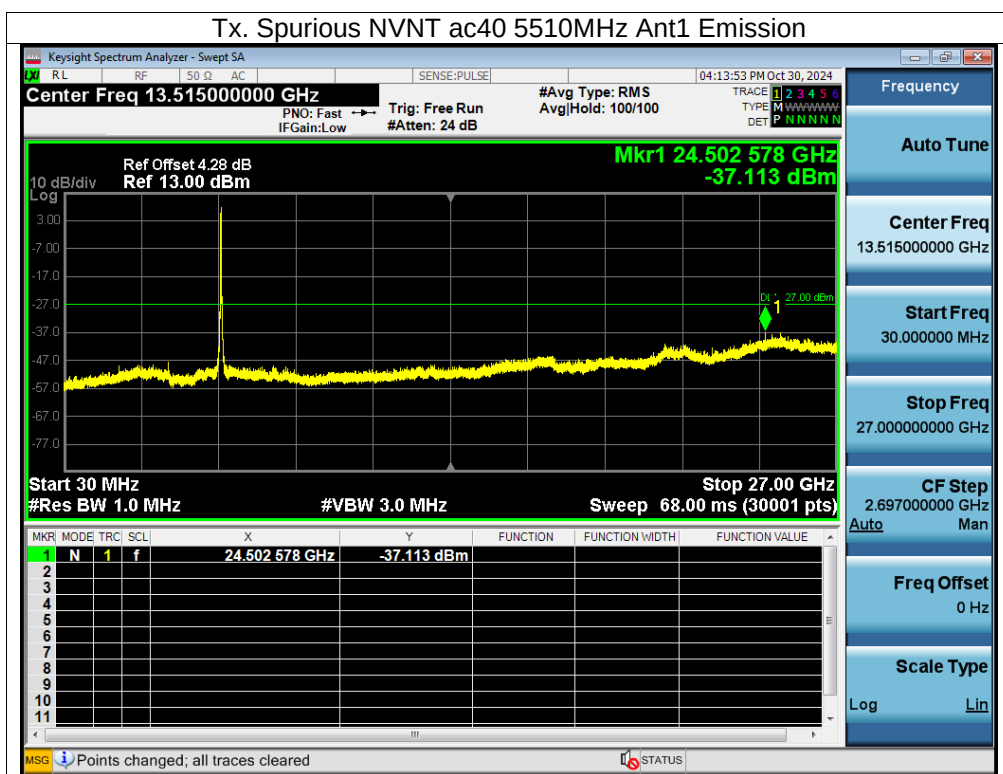


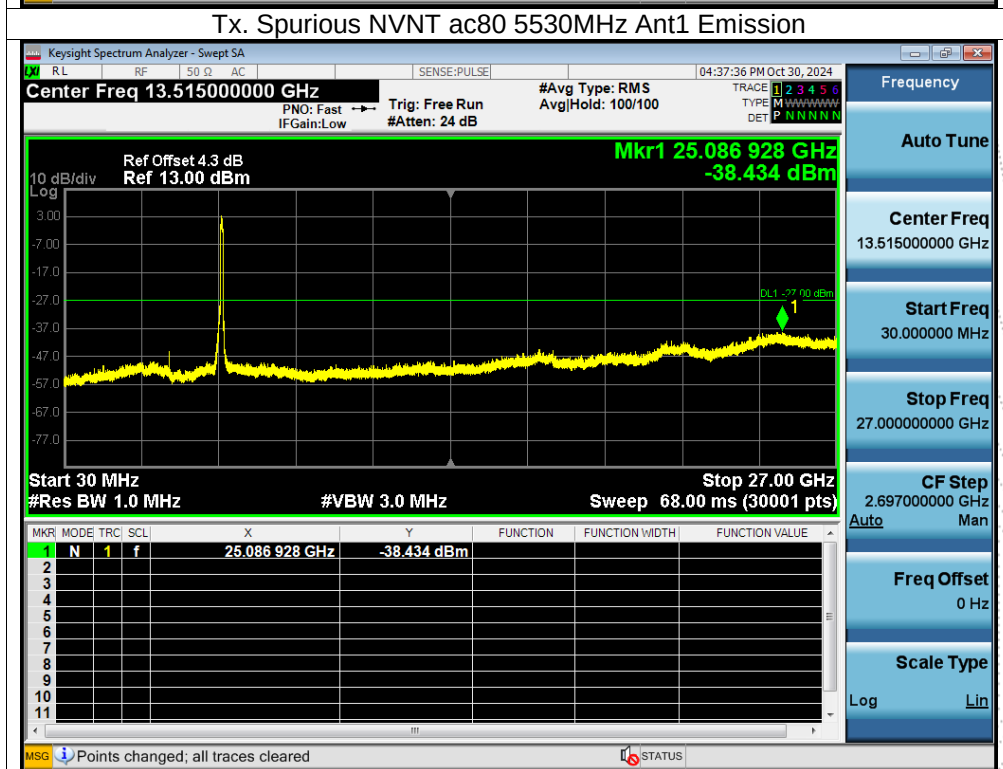
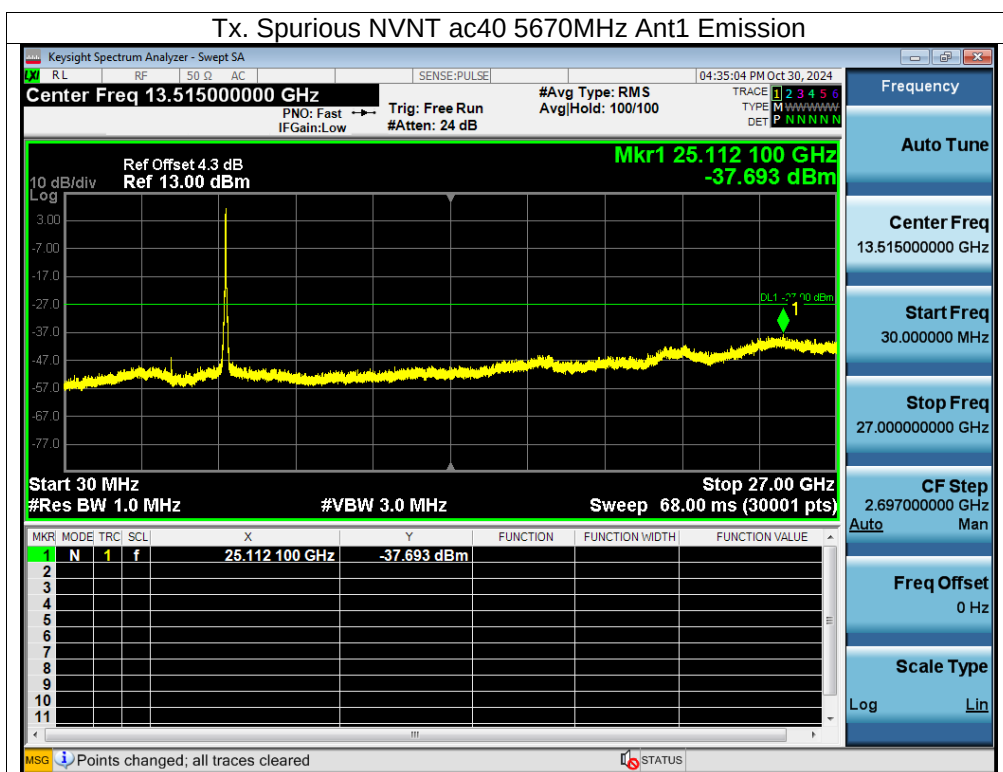




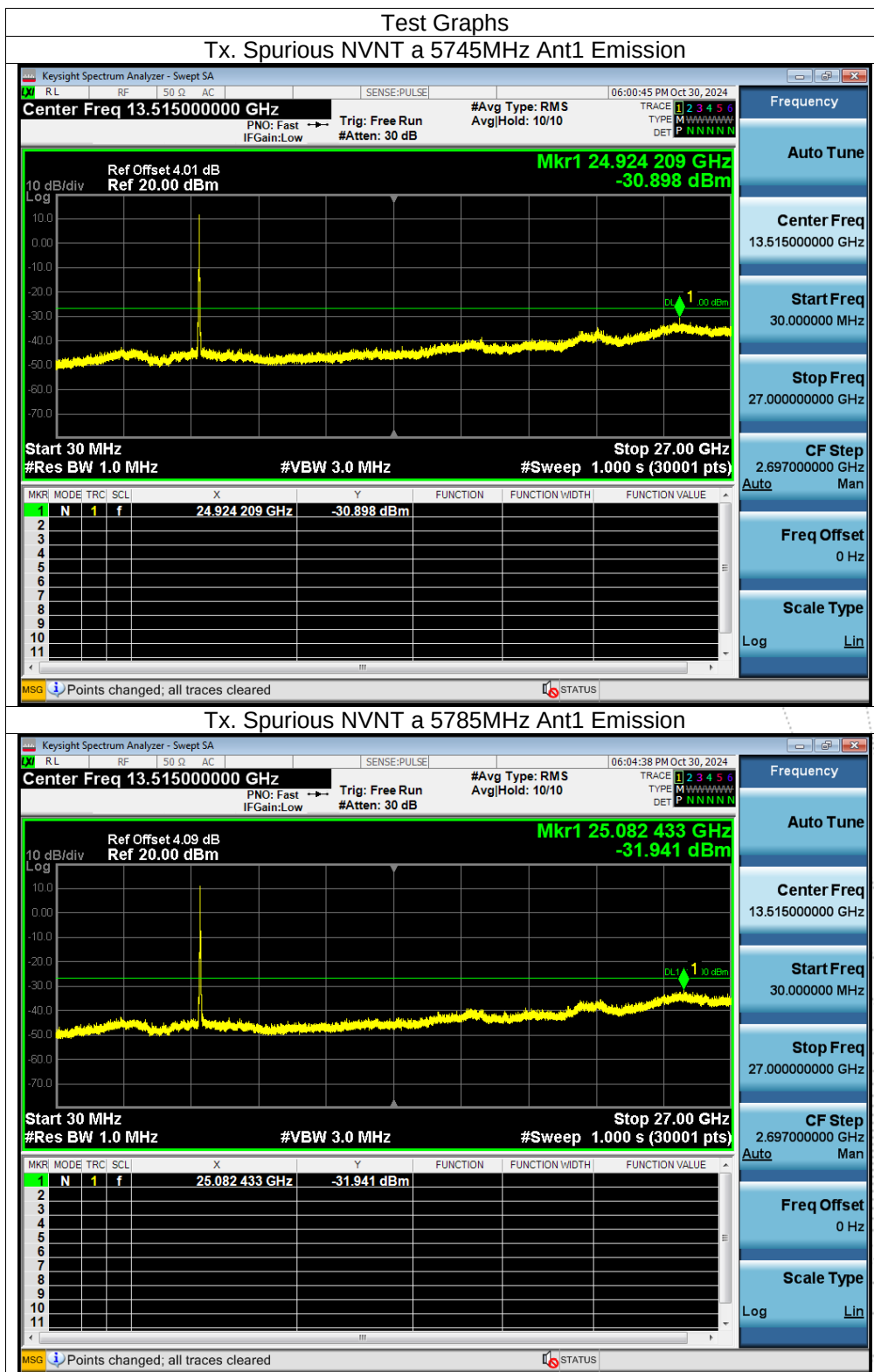


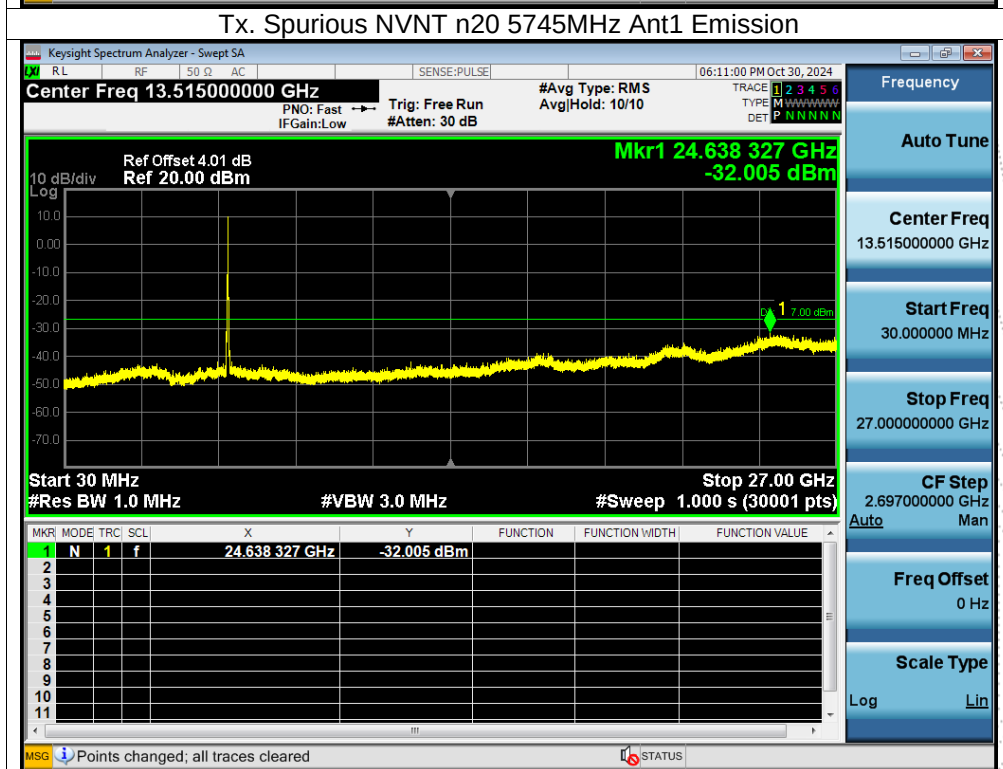
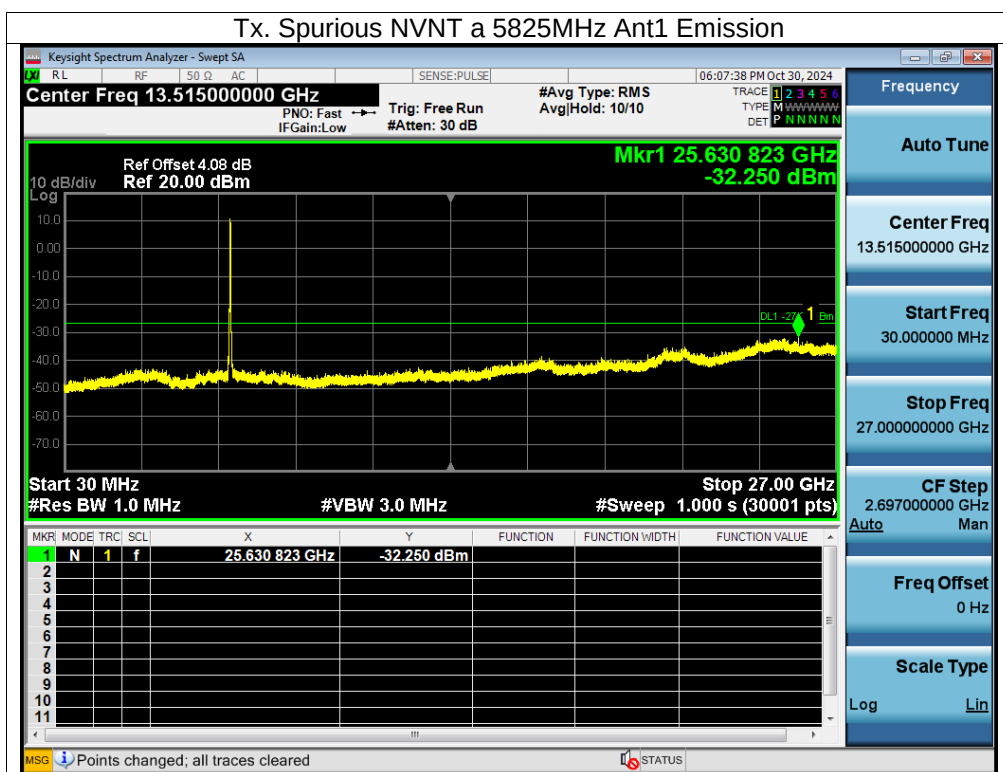


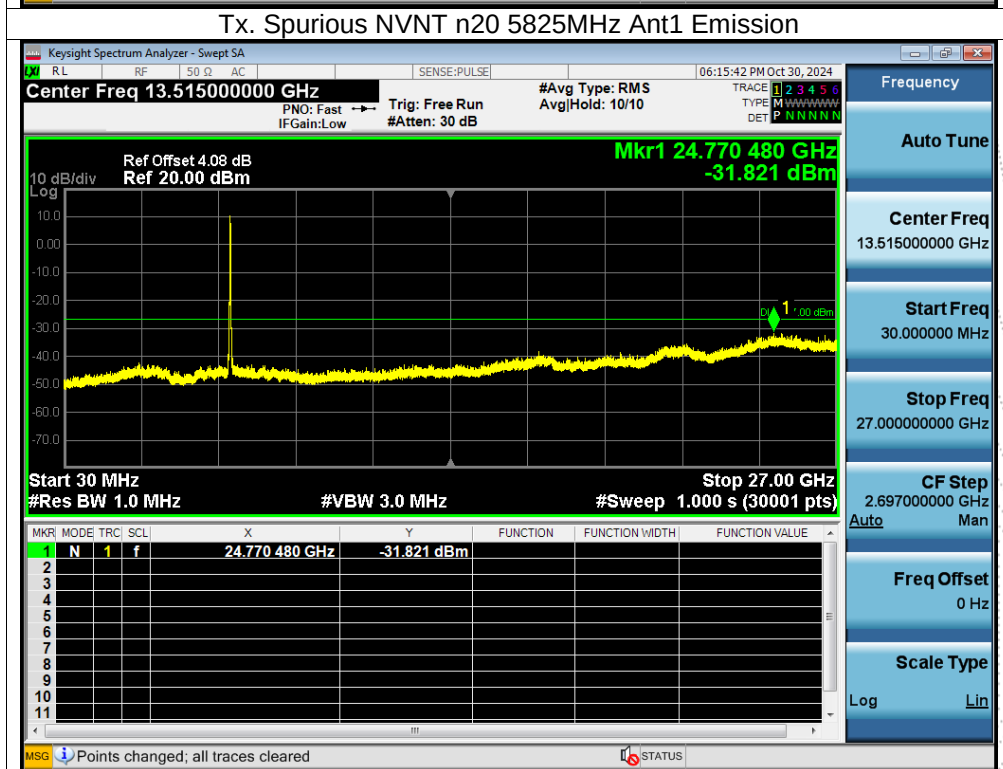
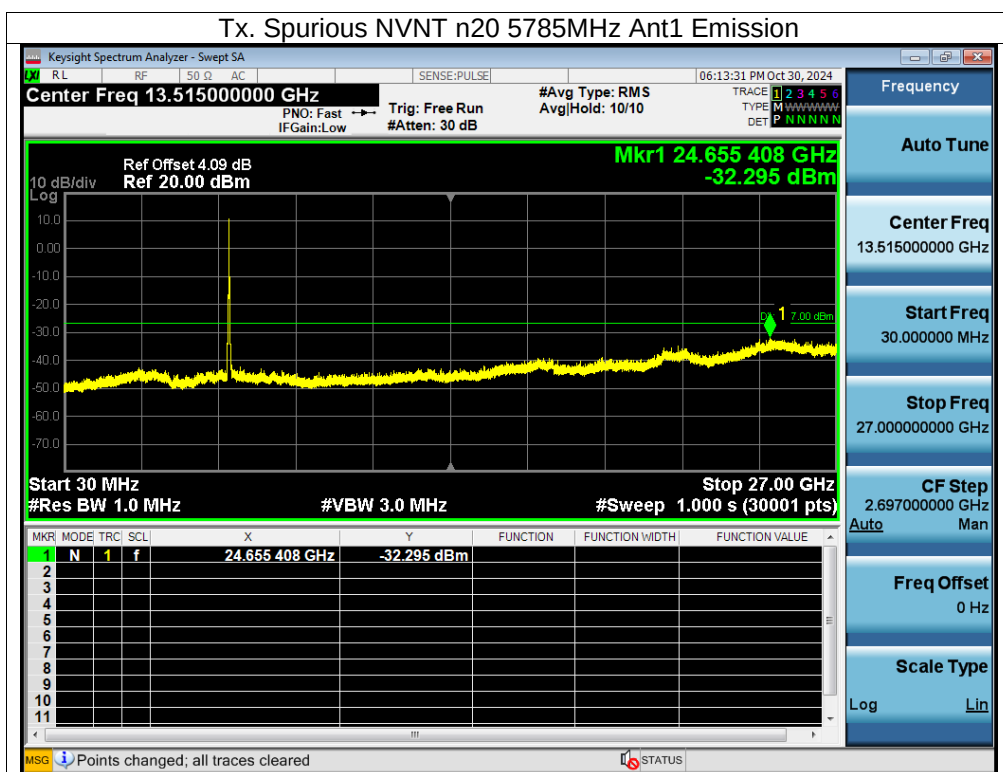


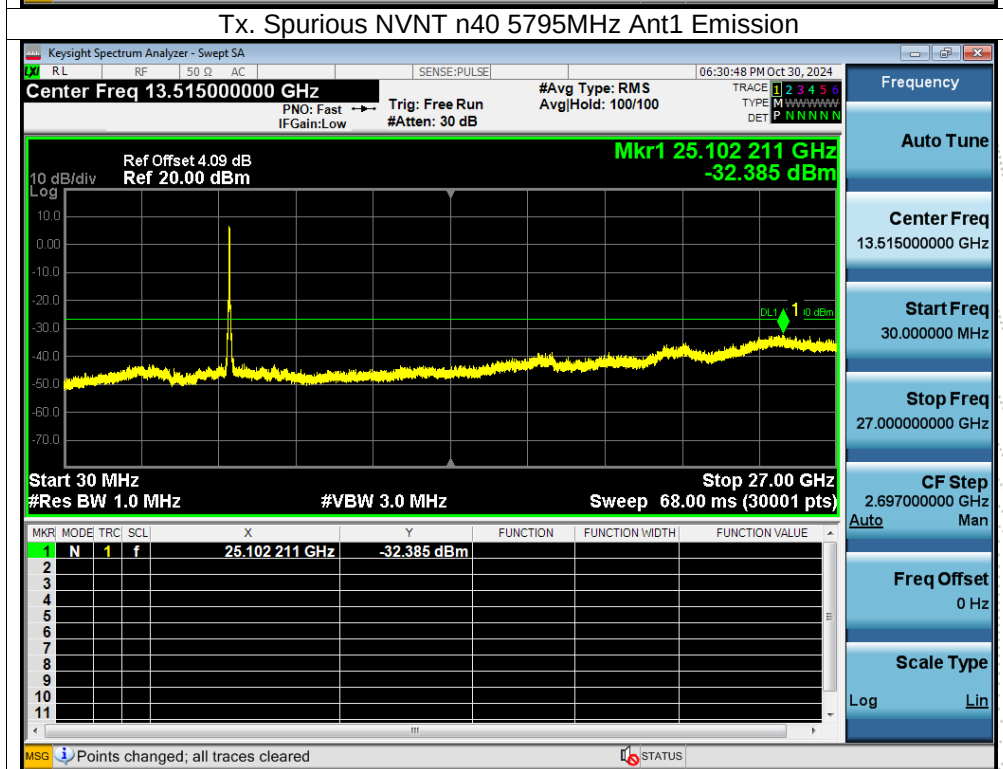
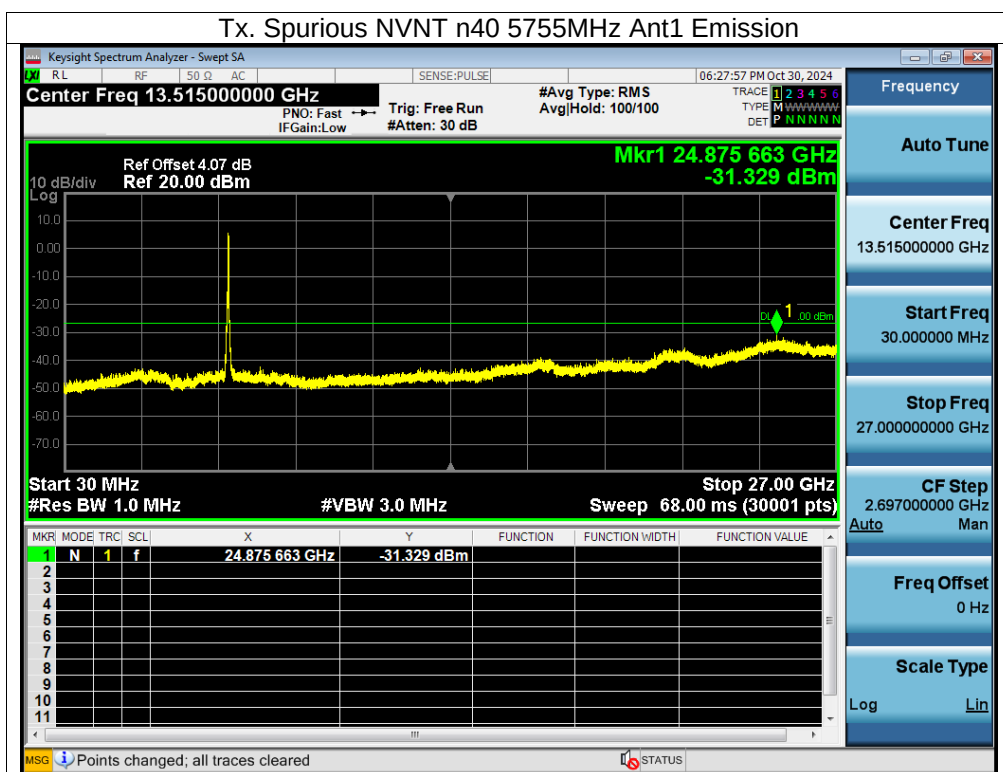


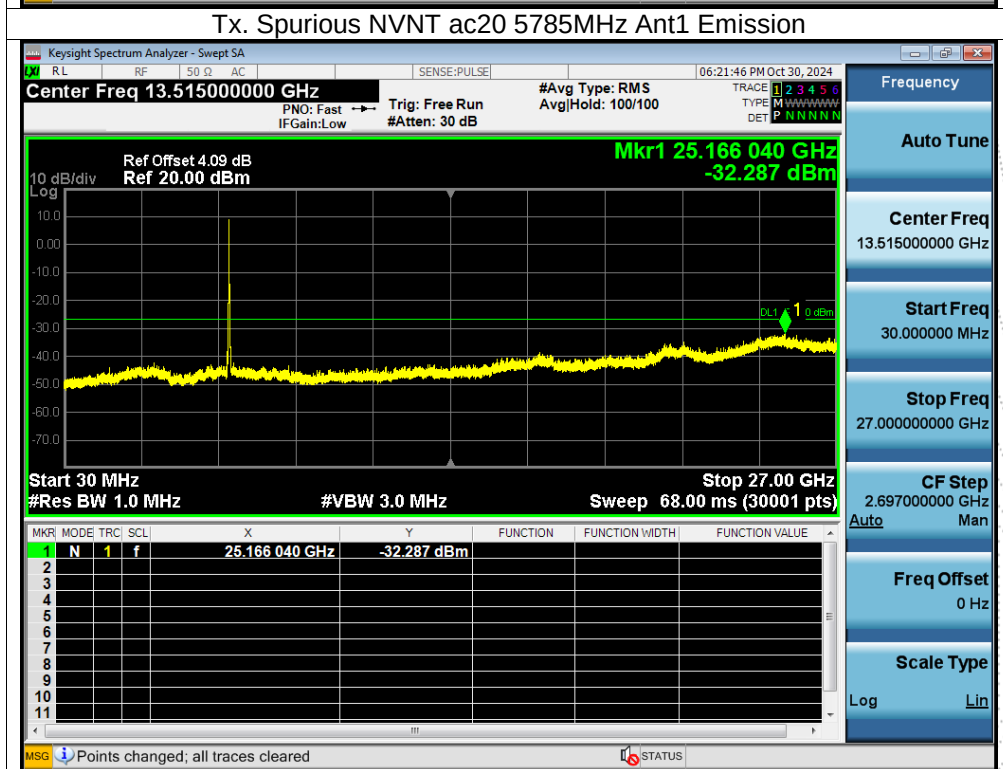
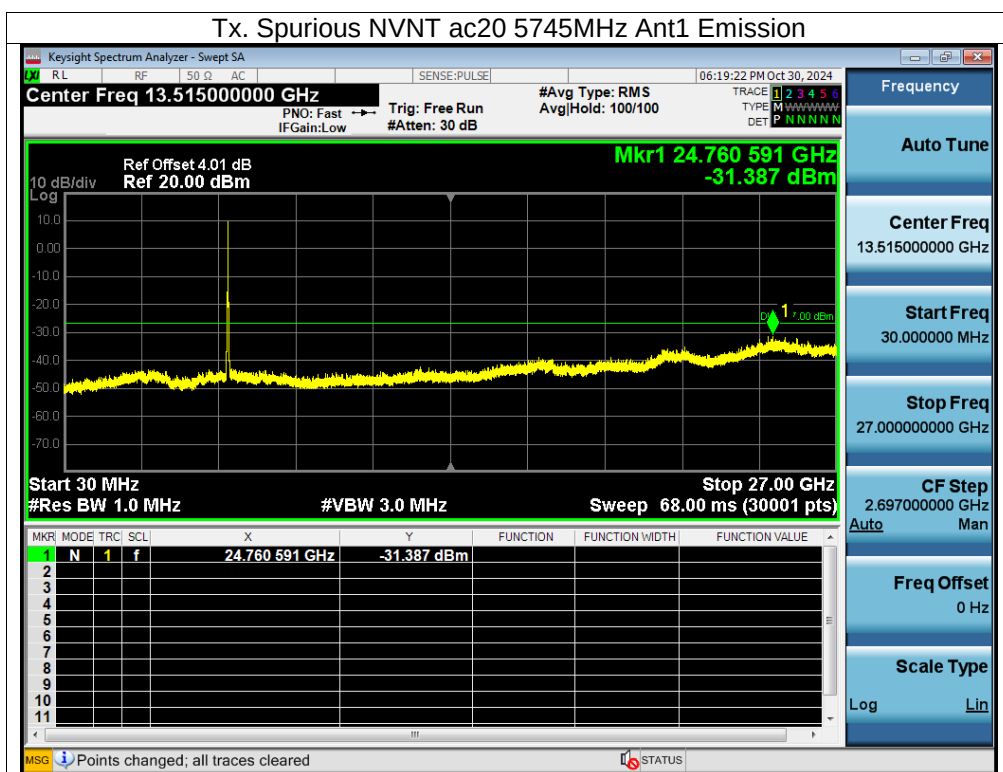
Test Mode:	5745-5825MHz
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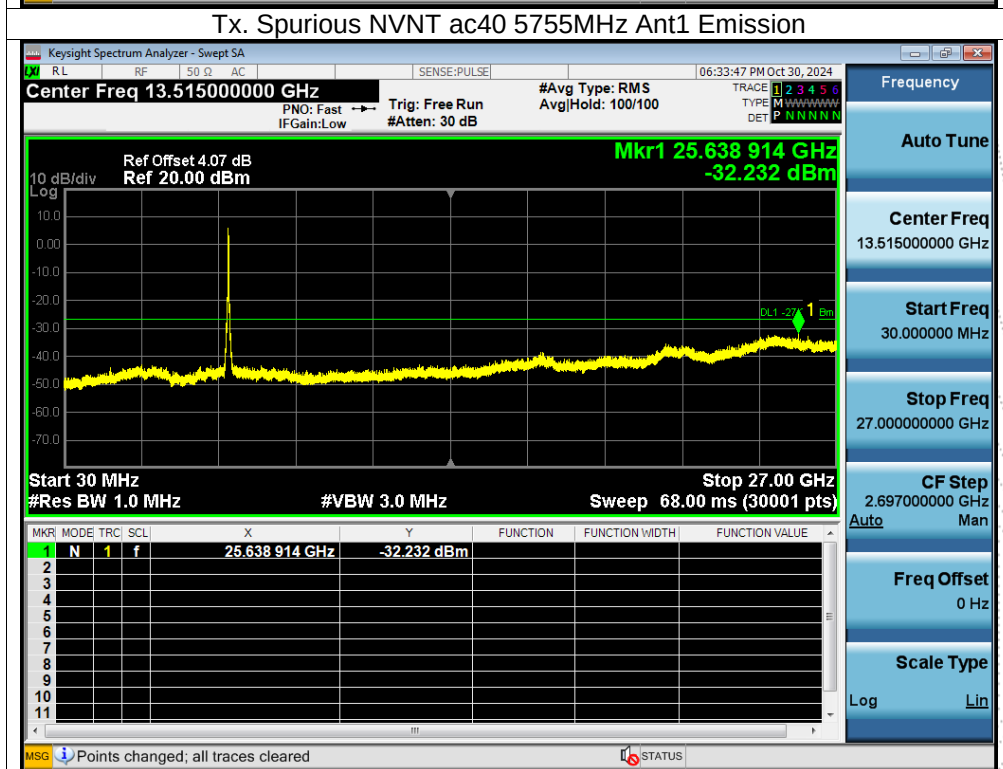
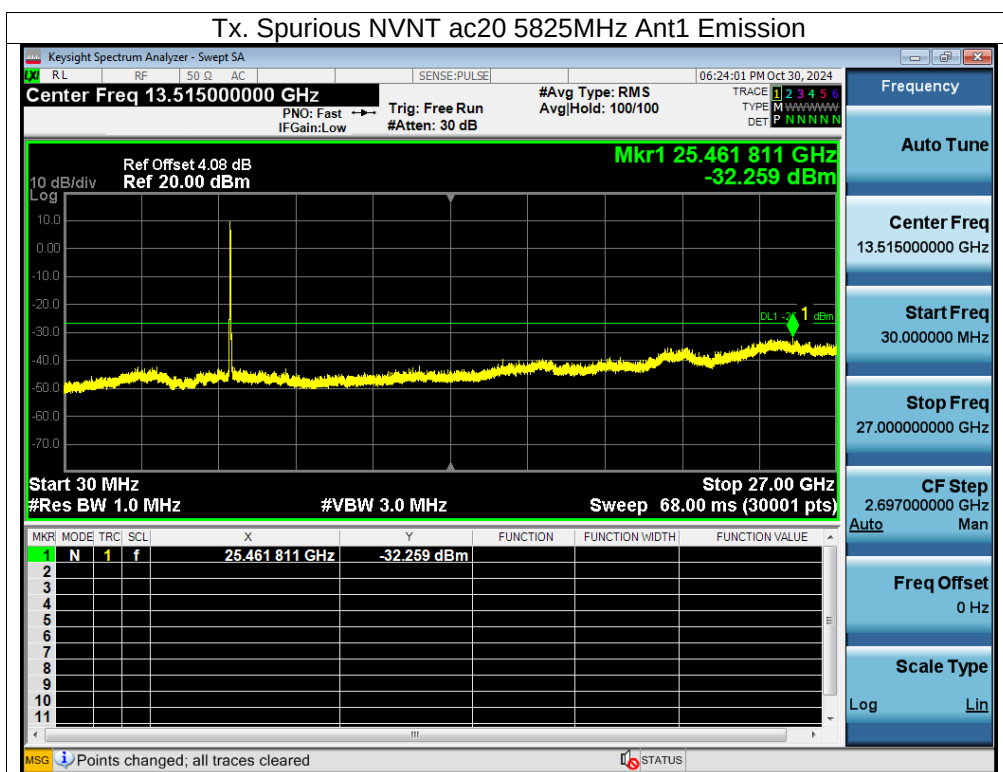


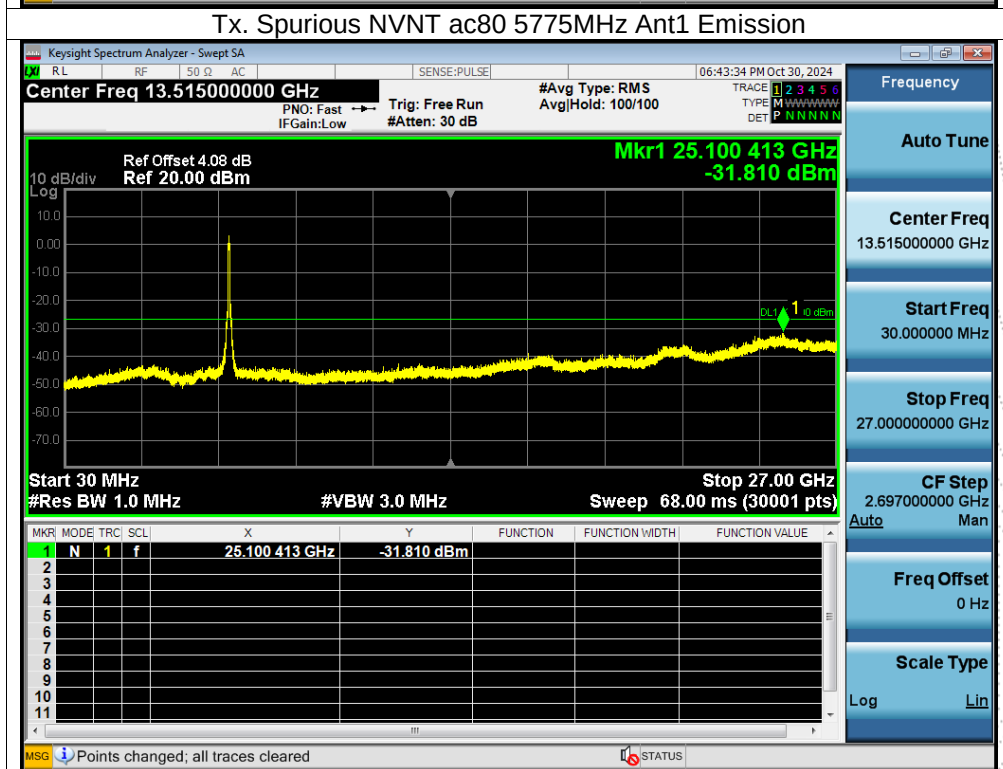
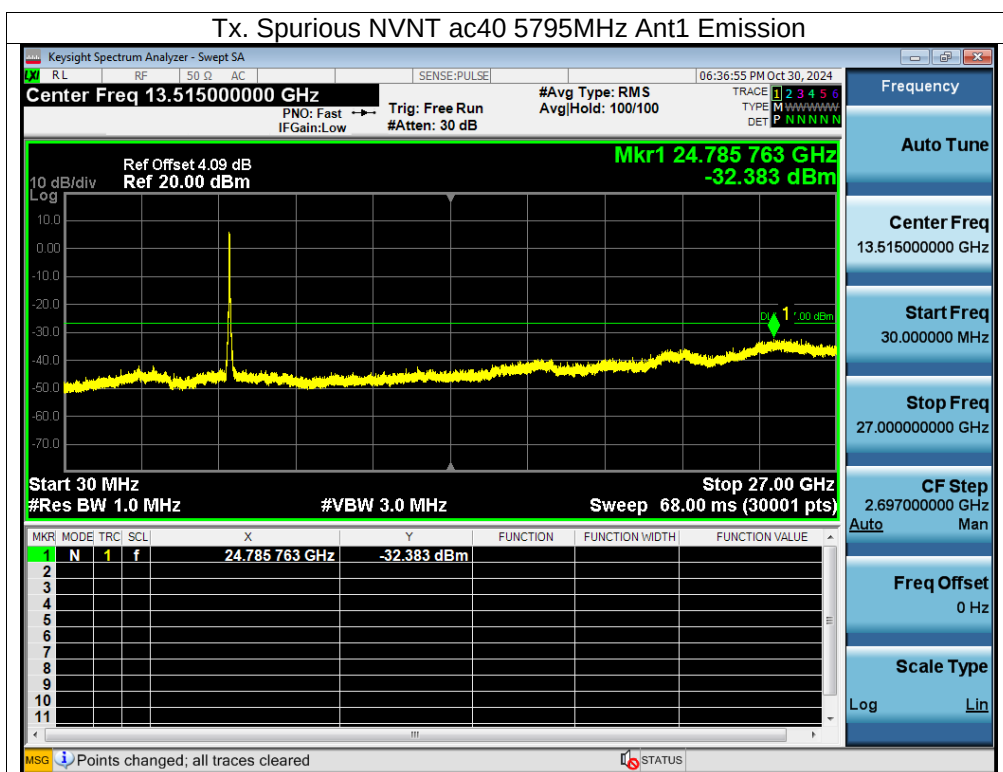












13. Frequency Stability Measurement

13.1 Block Diagram Of Test Setup



13.2 Limit

Manufactures of U-NII devices are responsible for ensuring frequency stability such that an emission is maintained within the band of operation under all conditions of normal operation as specified in the user's manual.

The transmitter center frequency tolerance shall be ± 20 ppm maximum for the 5 GHz band (IEEE 802.11n specification)..

13.3 Test Procedure

1. The transmitter output (antenna port) was connected to the spectrum analyzer.
2. EUT have transmitted absence of modulation signal and fixed channelize.
3. Set the spectrum analyzer span to view the entire absence of modulation emissions bandwidth.
4. Set RBW = 10 kHz, VBW = 10 kHz with peak detector and maxhold settings.
5. f_c is declaring of channel frequency. Then the frequency error formula is $(f_c - f)/f_c \times 10^6$ ppm and he limit is less than ± 20 ppm (IEEE 802.11n specification).
6. The test extreme voltage is to change the primary supply voltage from 85 to 115 percent of the nominal value
7. Extreme temperature is $-20^\circ\text{C} \sim 70^\circ\text{C}$.

13.4 Test Result

Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101KPa	Test Voltage:	DC 3.7V
Test Mode:	TX (5.1G) Mode Frequency U-NII-1 (5180-5240MHz)		

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5180MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.70	5180.0140	5180	0.0140	2.6954
		V max (V)	4.26	5180.0178	5180	0.0178	3.4347
		V min (V)	3.15	5180.0091	5180	0.0091	1.7523
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5180MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.7	T (°C)	-20	5180.0058	5180	0.0058	1.1208
		T (°C)	-10	5180.0112	5180	0.0112	2.1556
		T (°C)	0	5180.0135	5180	0.0135	2.6004
		T (°C)	10	5180.0090	5180	0.0090	1.7314
		T (°C)	20	5180.0099	5180	0.0099	1.9110
		T (°C)	30	5180.0134	5180	0.0134	2.5789
		T (°C)	40	5180.0096	5180	0.0096	1.8519
		T (°C)	50	5180.0088	5180	0.0088	1.7001
		T (°C)	60	5180.0069	5180	0.0069	1.3390
		T (°C)	70	5180.0102	5180	0.0102	1.9781
Limits				5150-5250 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5200MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.70	5200.0006	5200	0.0006	0.1200
		V max (V)	4.26	5200.0097	5200	0.0097	1.8741
		V min (V)	3.15	5200.0041	5200	0.0041	0.7888
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency : 5200MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.7	T (°C)	-20	5200.01178	5200	0.01178	2.2645
		T (°C)	-10	5200.00775	5200	0.00775	1.4912
		T (°C)	0	5200.01199	5200	0.01199	2.3056
		T (°C)	10	5200.00342	5200	0.00342	0.6584
		T (°C)	20	5200.00296	5200	0.00296	0.5691
		T (°C)	30	5200.00432	5200	0.00432	0.8314
		T (°C)	40	5200.00851	5200	0.00851	1.6370
		T (°C)	50	5200.01048	5200	0.01048	2.0158
		T (°C)	60	5200.00260	5200	0.00260	0.4999
		T (°C)	70	5200.00248	5200	0.00248	0.4772
Limits				5150-5250 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5240MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.70	5240.0128	5240	0.0128	2.4434
		V max (V)	4.26	5240.0065	5240	0.0065	1.2429
		V min (V)	3.15	5240.0061	5240	0.0061	1.1708
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency : 5240MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.7	T (°C)	-20	5240.0077	5240	0.0077	1.4735
		T (°C)	-10	5240.0042	5240	0.0042	0.8050
		T (°C)	0	5240.0013	5240	0.0013	0.2425
		T (°C)	10	5240.0066	5240	0.0066	1.2672
		T (°C)	20	5240.0001	5240	0.0001	0.0104
		T (°C)	30	5240.0063	5240	0.0063	1.2042
		T (°C)	40	5240.0058	5240	0.0058	1.1137
		T (°C)	50	5240.0057	5240	0.0057	1.0849
		T (°C)	60	5240.0025	5240	0.0025	0.4711
		T (°C)	70	5240.0028	5240	0.0028	0.5344
Limits				5150-5250 MHz			
Result				Complies			

Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101KPa	Test Voltage:	DC 3.7V
Test Mode:	TX (5.3G) Mode Frequency U-NII-2A (5260-5320MHz)		

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5260MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.70	5260.0161	5260	0.0161	3.06
		V max (V)	4.26	5260.0015	5260	0.0015	0.28
		V min (V)	3.15	5260.0072	5260	0.0072	1.36
Limits				5250-5350 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5260MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.7	T (°C)	-20	5260.0005	5260	0.0005	0.10
		T (°C)	-10	5260.0032	5260	0.0032	0.60
		T (°C)	0	5260.0043	5260	0.0043	0.82
		T (°C)	10	5260.0066	5260	0.0066	1.26
		T (°C)	20	5260.0037	5260	0.0037	0.71
		T (°C)	30	5260.0078	5260	0.0078	1.49
		T (°C)	40	5260.0119	5260	0.0119	2.26
		T (°C)	50	5260.0010	5260	0.0010	0.19
		T (°C)	60	5260.0012	5260	0.0012	0.23
		T (°C)	70	5260.0059	5260	0.0059	1.12
Limits				5250-5350 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5280MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.70	5280.0099	5280	0.0099	1.88
		V max (V)	4.26	5280.0126	5280	0.0126	2.39
		V min (V)	3.15	5280.0049	5280	0.0049	0.94
Limits				5250-5350 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency : 5280MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.7	T (°C)	-20	5280.00531	5280	0.00531	1.01
		T (°C)	-10	5280.00229	5280	0.00229	0.43
		T (°C)	0	5280.00526	5280	0.00526	1.00
		T (°C)	10	5280.00710	5280	0.00710	1.34
		T (°C)	20	5280.00587	5280	0.00587	1.11
		T (°C)	30	5280.00191	5280	0.00191	0.36
		T (°C)	40	5280.00943	5280	0.00943	1.79
		T (°C)	50	5280.00305	5280	0.00305	0.58
		T (°C)	60	5280.00966	5280	0.00966	1.83
		T (°C)	70	5280.00740	5280	0.00740	1.40
Limits				5250-5350 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5320MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.70	5320.0128	5320	0.0128	2.41
		V max (V)	4.26	5320.0039	5320	0.0039	0.73
		V min (V)	3.15	5320.0060	5320	0.0060	1.13
Limits				5250-5350 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency : 5320MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.7	T (°C)	-20	5320.0062	5320	0.0062	1.16
		T (°C)	-10	5320.0041	5320	0.0041	0.78
		T (°C)	0	5320.0050	5320	0.0050	0.95
		T (°C)	10	5320.0091	5320	0.0091	1.71
		T (°C)	20	5320.0112	5320	0.0112	2.11
		T (°C)	30	5320.0026	5320	0.0026	0.48
		T (°C)	40	5320.0010	5320	0.0010	0.20
		T (°C)	50	5320.0100	5320	0.0100	1.88
		T (°C)	60	5320.0095	5320	0.0095	1.78
		T (°C)	70	5320.0023	5320	0.0023	0.44
Limits				5250-5350 MHz			
Result				Complies			

Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101KPa	Test Voltage:	DC 3.7V
Test Mode:	TX (5.6G) Mode Frequency U-NII-2C (5500-5700MHz)		

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5500MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.70	5500.0168	5500	0.0168	3.05
		V max (V)	4.26	5500.0090	5500	0.0090	1.63
		V min (V)	3.15	5500.0085	5500	0.0085	1.55
Limits				5470-5720 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5500MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.7	T (°C)	-20	5500.0089	5500	0.0089	1.62
		T (°C)	-10	5500.0095	5500	0.0095	1.73
		T (°C)	0	5500.0100	5500	0.0100	1.82
		T (°C)	10	5500.0023	5500	0.0023	0.41
		T (°C)	20	5500.0059	5500	0.0059	1.07
		T (°C)	30	5500.0125	5500	0.0125	2.27
		T (°C)	40	5500.0044	5500	0.0044	0.81
		T (°C)	50	5500.0044	5500	0.0044	0.80
		T (°C)	60	5500.0106	5500	0.0106	1.93
		T (°C)	70	5500.0020	5500	0.0020	0.37
Limits				5470-5720 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5580MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.70	5580.0096	5580	0.0096	1.71
		V max (V)	4.26	5580.0114	5580	0.0114	2.04
		V min (V)	3.15	5580.0030	5580	0.0030	0.54
Limits				5470-5720 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency : 5580MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.7	T (°C)	-20	5580.00695	5580	0.00695	1.24
		T (°C)	-10	5580.00497	5580	0.00497	0.89
		T (°C)	0	5580.00579	5580	0.00579	1.04
		T (°C)	10	5580.00409	5580	0.00409	0.73
		T (°C)	20	5580.00057	5580	0.00057	0.10
		T (°C)	30	5580.00345	5580	0.00345	0.62
		T (°C)	40	5580.00985	5580	0.00985	1.77
		T (°C)	50	5580.01260	5580	0.01260	2.26
		T (°C)	60	5580.00799	5580	0.00799	1.43
		T (°C)	70	5580.00258	5580	0.00258	0.46
Limits				5470-5720 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5700MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.70	5700.0127	5700	0.0127	2.22
		V max (V)	4.26	5700.0057	5700	0.0057	0.99
		V min (V)	3.15	5700.0047	5700	0.0047	0.82
Limits				5470-5720 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5700MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.7	T (°C)	-20	5700.0074	5700	0.0074	1.29
		T (°C)	-10	5700.0024	5700	0.0024	0.43
		T (°C)	0	5700.0038	5700	0.0038	0.67
		T (°C)	10	5700.0090	5700	0.0090	1.58
		T (°C)	20	5700.0133	5700	0.0133	2.34
		T (°C)	30	5700.0133	5700	0.0133	2.33
		T (°C)	40	5700.0038	5700	0.0038	0.66
		T (°C)	50	5700.0026	5700	0.0026	0.46
		T (°C)	60	5700.0103	5700	0.0103	1.81
		T (°C)	70	5700.0087	5700	0.0087	1.53
Limits				5470-5720 MHz			
Result				Complies			

Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101KPa	Test Voltage:	DC 3.7V
Test Mode:	TX (5.8G) Mode Frequency U-NII-3 (5745-5825MHz)		

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5745MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.70	5745.01121	5745	0.01121	1.9507
		V max (V)	4.26	5745.00852	5745	0.00852	1.4822
		V min (V)	3.15	5745.00831	5745	0.00831	1.4468
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5745MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.7	T (°C)	-20	5745.00533	5745	0.00533	0.9278
		T (°C)	-10	5745.00299	5745	0.00299	0.5206
		T (°C)	0	5745.01030	5745	0.01030	1.7924
		T (°C)	10	5745.00425	5745	0.00425	0.7405
		T (°C)	20	5745.00698	5745	0.00698	1.2152
		T (°C)	30	5745.00983	5745	0.00983	1.7113
		T (°C)	40	5745.00686	5745	0.00686	1.1944
		T (°C)	50	5745.00835	5745	0.00835	1.4531
		T (°C)	60	5745.00267	5745	0.00267	0.4647
		T (°C)	70	5745.01033	5745	0.01033	1.7978
Limits				5725-5850 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5785MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.70	5785.00073	5785	0.00073	0.1266
		V max (V)	4.26	5785.01025	5785	0.01025	1.7723
		V min (V)	3.15	5785.00345	5785	0.00345	0.5965
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5785MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.7	T (°C)	-20	5785.00129	5785	0.00129	0.2232
		T (°C)	-10	5785.00142	5785	0.00142	0.2460
		T (°C)	0	5785.01016	5785	0.01016	1.7569
		T (°C)	10	5785.00523	5785	0.00523	0.9038
		T (°C)	20	5785.01290	5785	0.01290	2.2301
		T (°C)	30	5785.00003	5785	0.00003	0.0055
		T (°C)	40	5785.00183	5785	0.00183	0.3162
		T (°C)	50	5785.00613	5785	0.00613	1.0605
		T (°C)	60	5785.00339	5785	0.00339	0.5852
		T (°C)	70	5785.00810	5785	0.00810	1.4004
Limits				5725-5850 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5825MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.70	5825.00603	5825	0.00603	1.0349
		V max (V)	4.26	5825.01180	5825	0.01180	2.0259
		V min (V)	3.15	5825.00155	5825	0.00155	0.2656
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency : 5825MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.7	T (°C)	-20	5825.01028	5825	0.01028	1.7645
		T (°C)	-10	5825.00529	5825	0.00529	0.9084
		T (°C)	0	5825.00332	5825	0.00332	0.5697
		T (°C)	10	5825.00608	5825	0.00608	1.0430
		T (°C)	20	5825.00657	5825	0.00657	1.1272
		T (°C)	30	5825.00850	5825	0.00850	1.4599
		T (°C)	40	5825.00384	5825	0.00384	0.6587
		T (°C)	50	5825.00336	5825	0.00336	0.5764
		T (°C)	60	5825.00618	5825	0.00618	1.0603
		T (°C)	70	5825.00111	5825	0.00111	0.1909
Limits				5725-5850 MHz			
Result				Complies			

14. Duty Cycle Of Test Signal

14.1 Standard Requirement

Pre-analysis Check: While conducting average power measurement, duty cycle of each mode shall be checked to ensure its duty cycle in order to compensate for the loss due to insufficient ratio of duty cycle. All duty cycle is pre-scanned, and result as obtained below shows only the most representative ones where duty cycle is conducted as the given transmission with given virtual operation that expresses the percentage.

14.2 Formula

Duty Cycle = $T_{on} / (T_{on} + T_{off})$

14.3 Test Procedure

1. Set span = Zero
2. RBW = 8MHz
3. VBW = 8MHz,
4. Detector = Peak

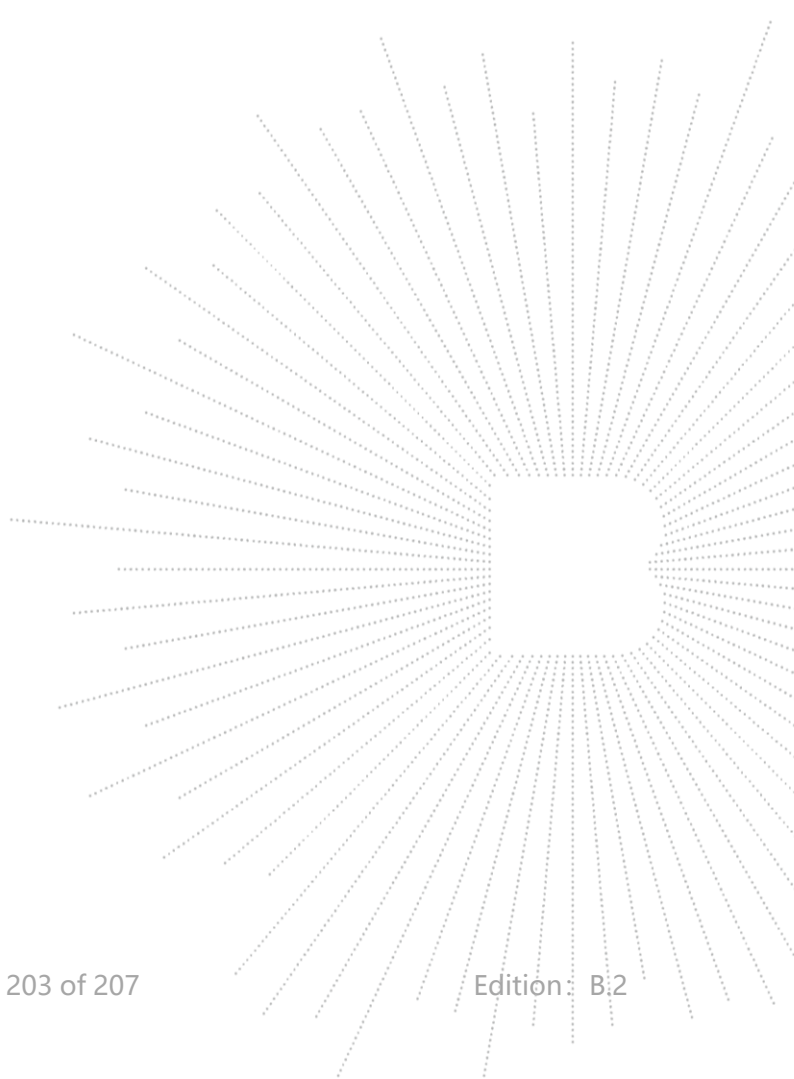
14.4 Test Result

Condition	Mode	Frequency (MHz)	Duty Cycle (%)
NVNT	a	5180	100
NVNT	a	5200	100
NVNT	a	5240	100
NVNT	n20	5180	100
NVNT	n20	5200	100
NVNT	n20	5240	100
NVNT	n40	5190	100
NVNT	n40	5230	100
NVNT	ac20	5180	100
NVNT	ac20	5200	100
NVNT	ac20	5240	100
NVNT	ac40	5190	100
NVNT	ac40	5230	100
NVNT	ac80	5210	100

Condition	Mode	Frequency (MHz)	Duty Cycle (%)
NVNT	a	5260	100
NVNT	a	5280	100
NVNT	a	5320	100
NVNT	n20	5260	100
NVNT	n20	5280	100
NVNT	n20	5320	100
NVNT	n40	5270	100
NVNT	n40	5310	100
NVNT	ac20	5260	100
NVNT	ac20	5280	100
NVNT	ac20	5320	100
NVNT	ac40	5270	100
NVNT	ac40	5310	100
NVNT	ac80	5290	100

Condition	Mode	Frequency (MHz)	Duty Cycle (%)
NVNT	a	5500	100
NVNT	a	5580	100
NVNT	a	5700	100
NVNT	n20	5500	100
NVNT	n20	5580	100
NVNT	n20	5700	100
NVNT	n40	5510	100
NVNT	n40	5550	100
NVNT	n40	5670	100
NVNT	ac20	5500	100
NVNT	ac20	5580	100
NVNT	ac20	5700	100
NVNT	ac40	5510	100
NVNT	ac40	5550	100
NVNT	ac40	5670	100
NVNT	ac80	5530	100

Condition	Mode	Frequency (MHz)	Duty Cycle (%)
NVNT	a	5745	100
NVNT	a	5785	100
NVNT	a	5825	100
NVNT	n20	5745	100
NVNT	n20	5785	100
NVNT	n20	5825	100
NVNT	n40	5755	100
NVNT	n40	5795	100
NVNT	ac20	5745	100
NVNT	ac20	5785	100
NVNT	ac20	5825	100
NVNT	ac40	5755	100
NVNT	ac40	5795	100
NVNT	ac80	5775	100



15. Antenna Requirement

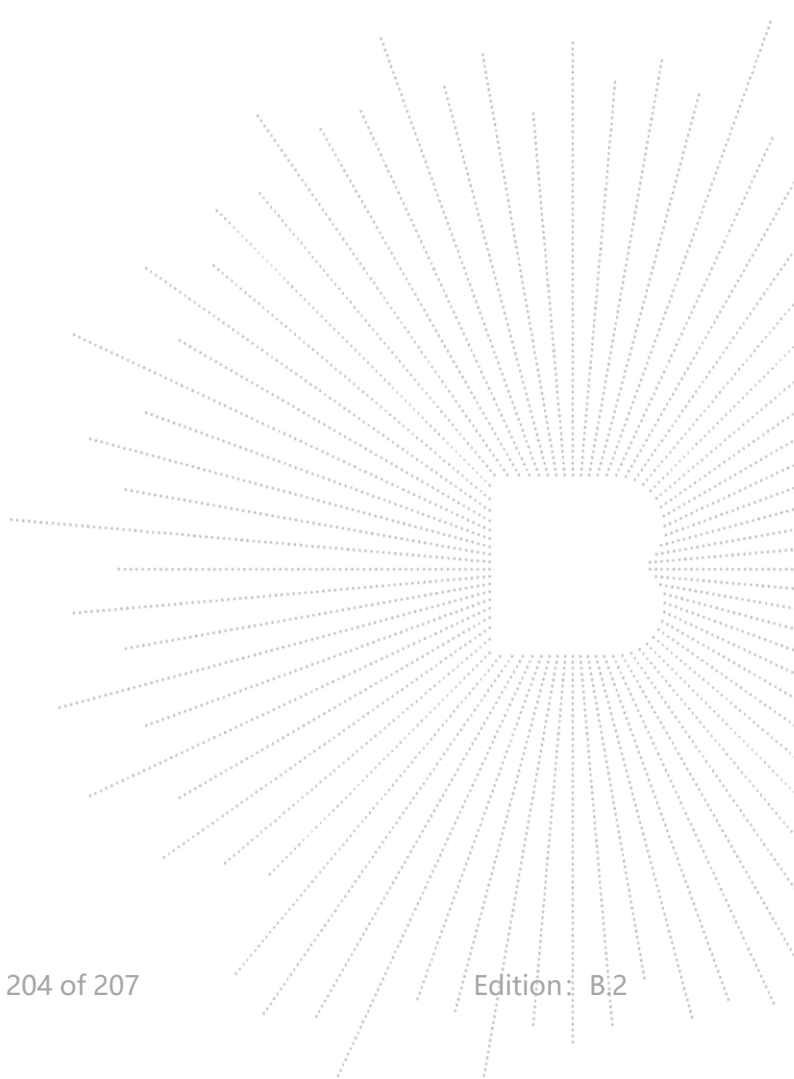
15.1 Limit

15.203 requirements:

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section. The manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited. This requirement does not apply to carrier current devices or to devices operated under the provisions of §15.211, §15.213, §15.217, §15.219, or §15.221. Further, this requirement does not apply to intentional radiators that must be professionally installed, such as perimeter protection systems and some field disturbance sensors, or to other intentional radiators which, in accordance with §15.31(d), must be measured at the installation site. However, the installer shall be responsible for ensuring that the proper antenna is employed so that the limits in this part are not exceeded.

15.2 Test Result

The EUT antenna is Internal antenna, not using a standard antenna jack or electrical connector for antenna replacement, fulfill the requirement of this section.



16. EUT Test Setup Photographs

Conducted Emissions Photo



Radiated Measurement Photos





STATEMENT

1. The equipment lists are traceable to the national reference standards.
2. The test report can not be partially copied unless prior written approval is issued from our lab.
3. The test report is invalid without the "special seal for inspection and testing".
4. The test report is invalid without the signature of the approver.
5. The test process and test result is only related to the Unit Under Test.
6. Sample information is provided by the client and the laboratory is not responsible for its authenticity.
7. The quality system of our laboratory is in accordance with ISO/IEC17025.
8. If there is any objection to this test report, the client should inform issuing laboratory within 15 days from the date of receiving test report.

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***** END *****